

Status on Z resolution of the Asian module with 2016 data

2nd LCTPC Topical Analysis Meeting :
z resolution and evt time

- Rough view for Z resolutions using 2016 beam data
- Simulation on behavior of the Z resolution (with very personal opinion)

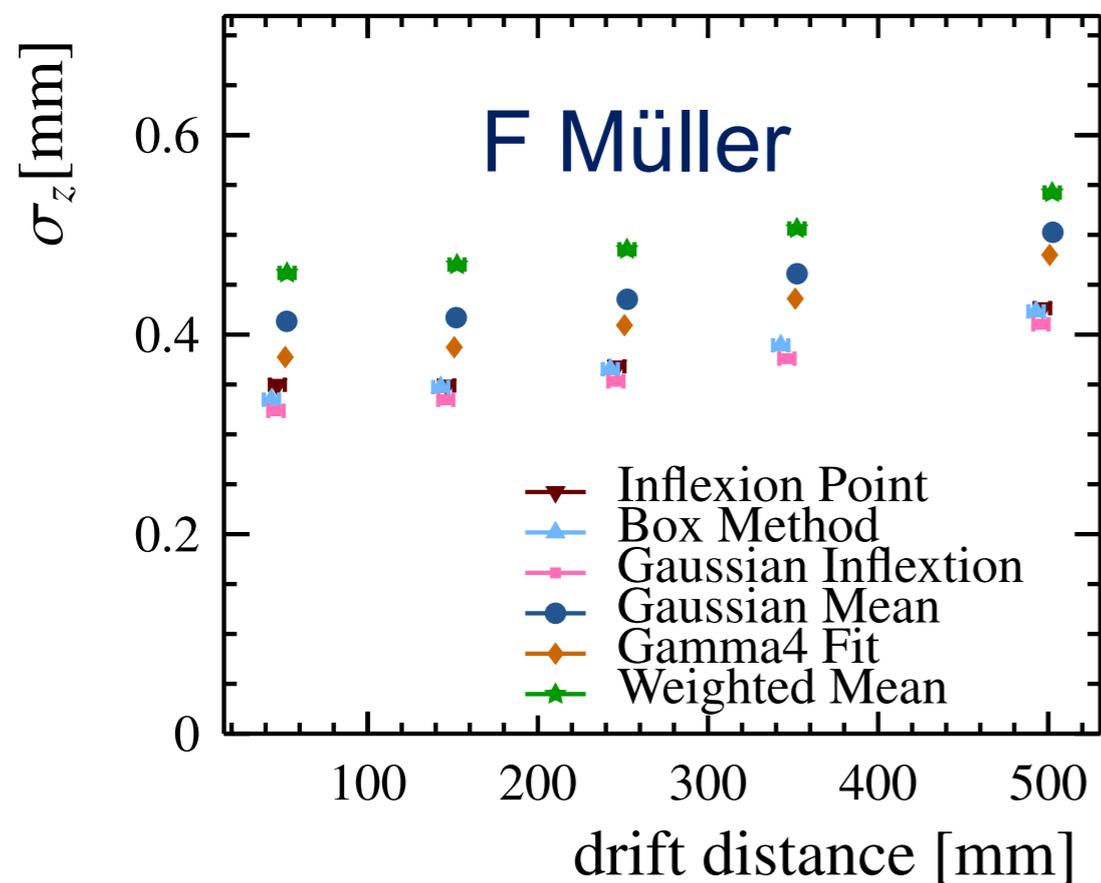
Time Estimators

A first important choice is a time estimator

It was well studied for GEM and Micromegas modules

DESY GEM

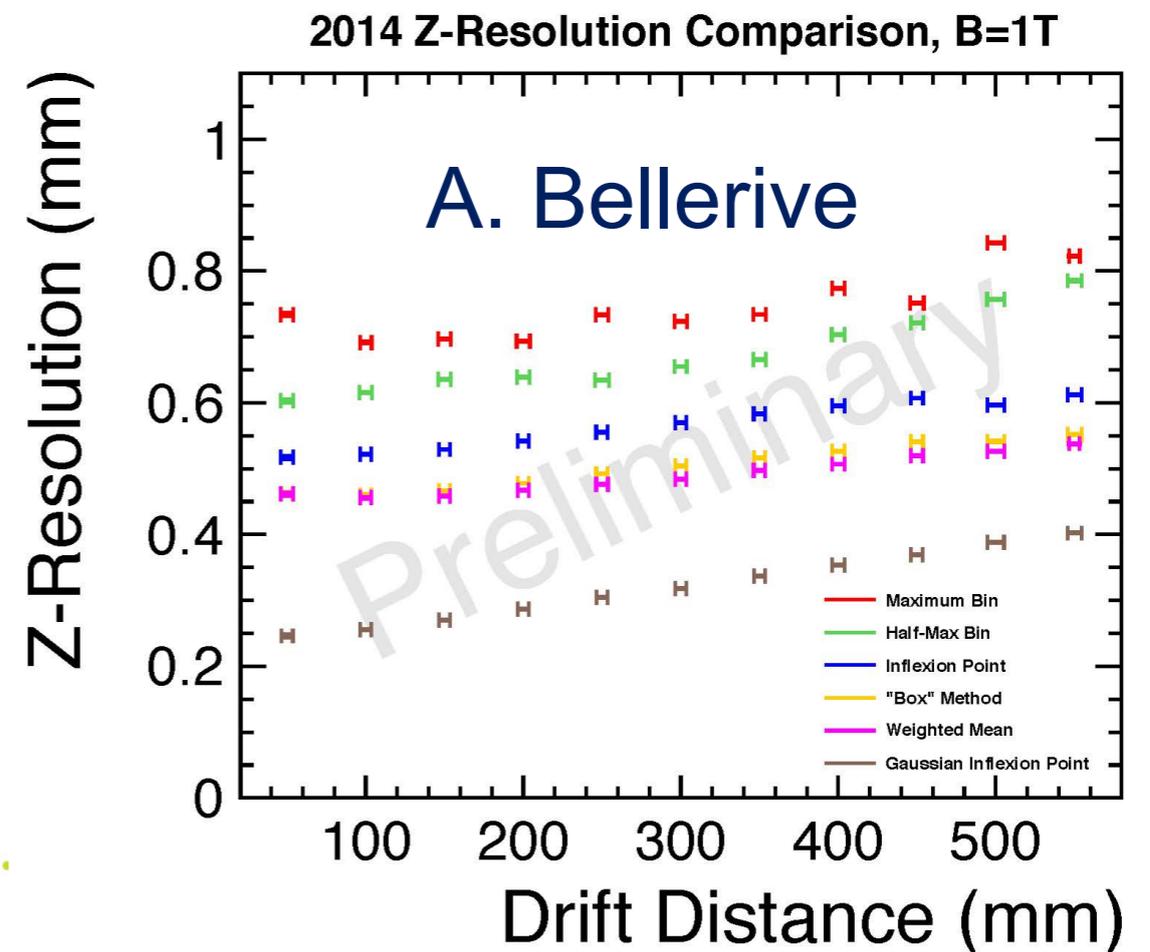
<http://bib-pubdb1.desy.de/search?cc=Publication+Database&of=hd&p=reportnumber:DESY-THESIS-2016-018>



(b) $B = 1 \text{ T}$

Micromegas

<https://agenda.linearcollider.org/event/6712/contributions/32958/>



Time Estimators

A first important choice is a time estimator

It was well studied for GEM and Micromegas modules

Cluster time is given

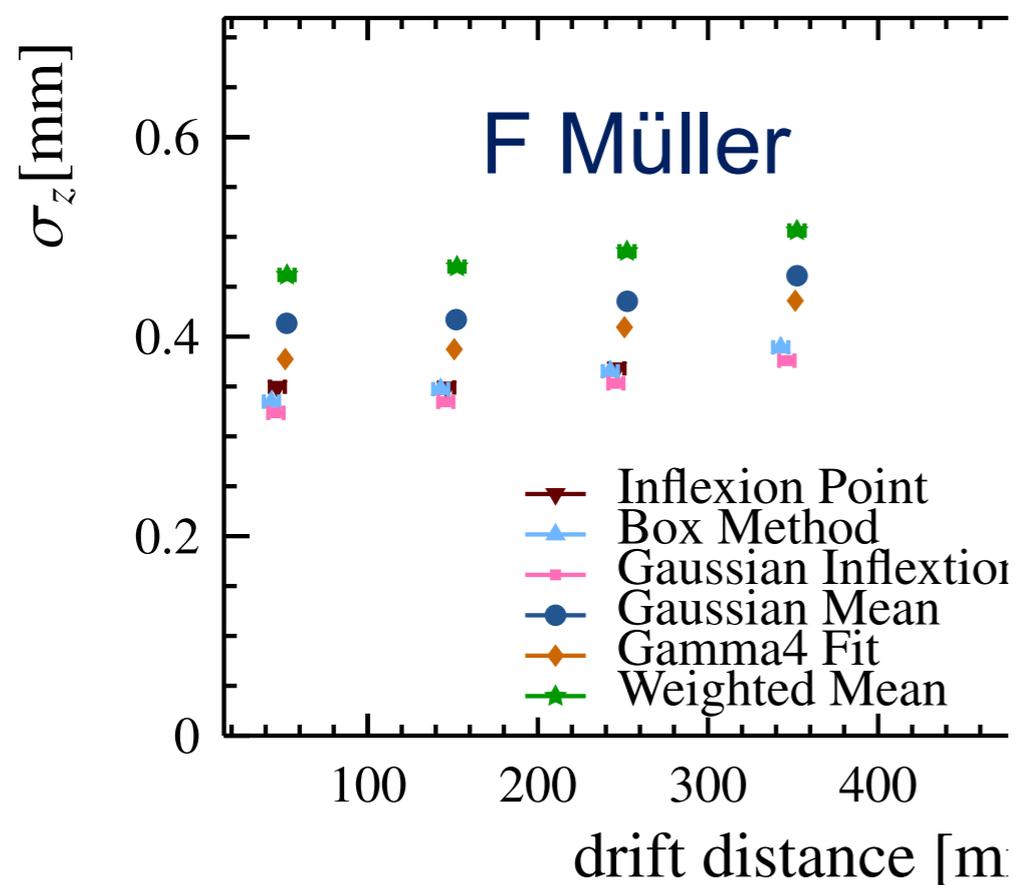
as a inflexion point.

(Marlin default)

Hit time is $\begin{cases} \text{maximum pulse time or} \\ \text{charge weighted mean} \end{cases}$

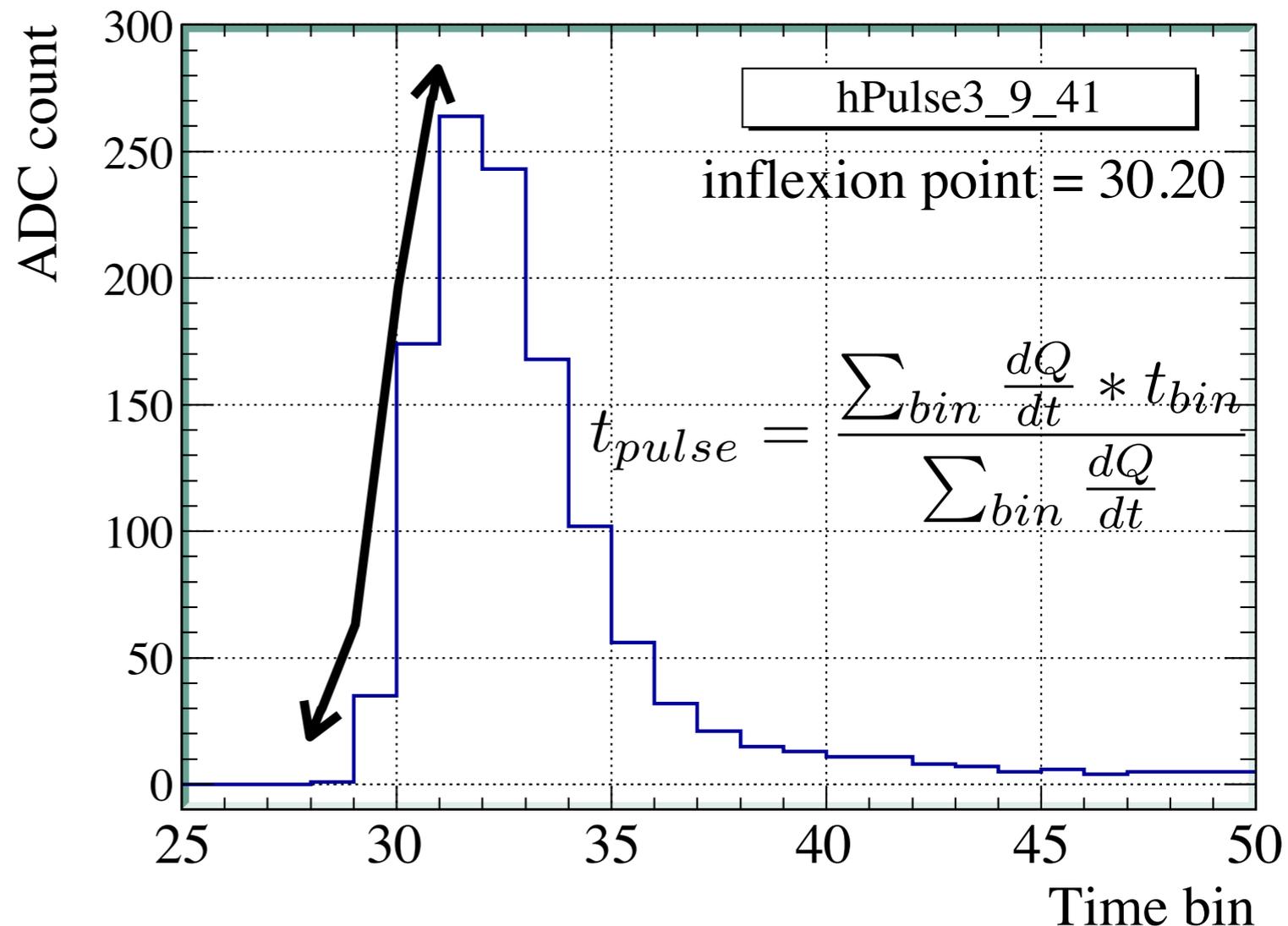
DESY GEM

<http://bib-pubdb1.desy.de/search?cc=Publication+Database&of=hd&p=reportnumber:DESY-THESIS-201>



(b) $B = 1 \text{ T}$

Row pulse distribution in certain pad

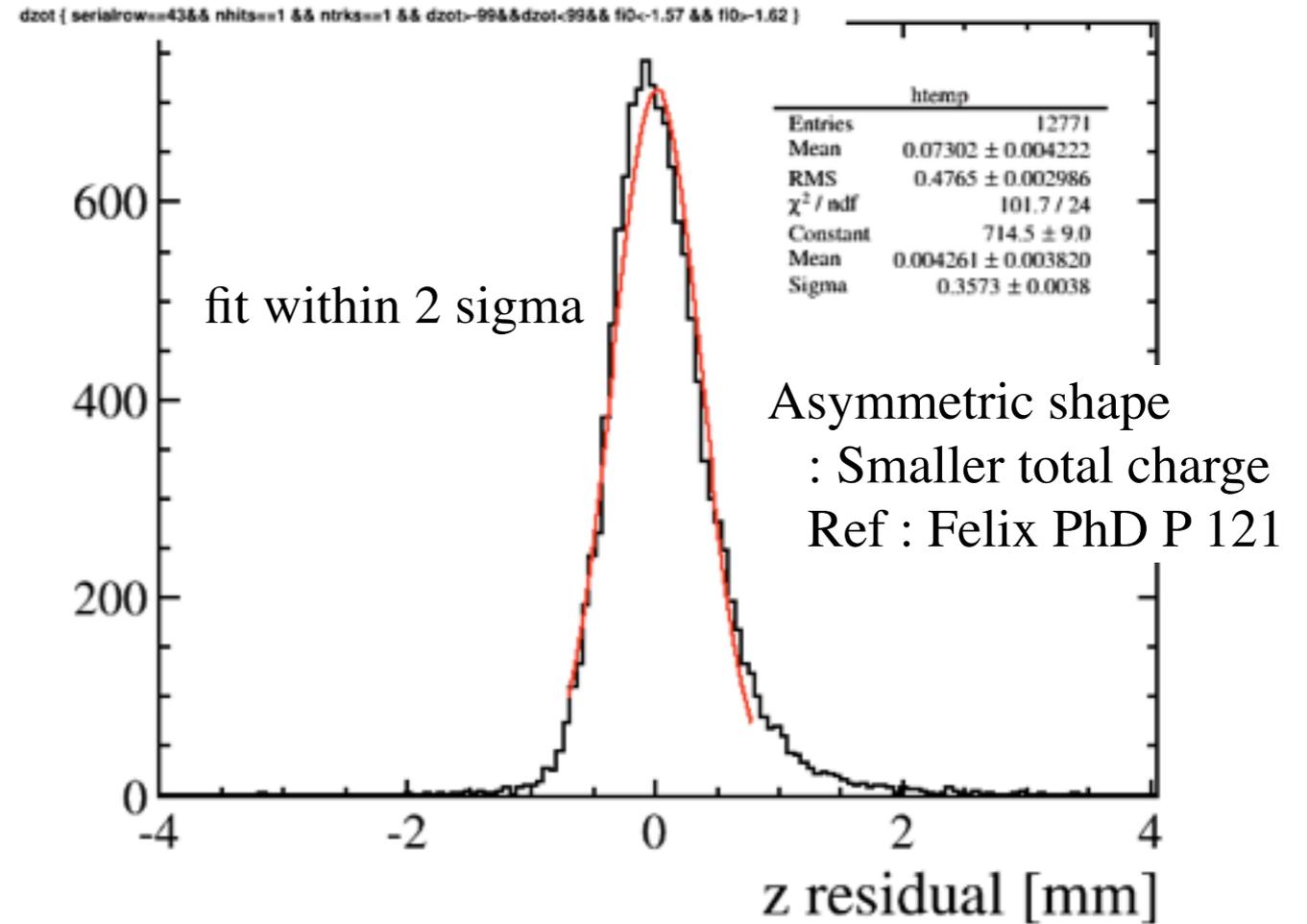


Z resolutions

Track quality cut:

- full data : 20.0 k events
 - 1 track in 1 event : ~16.5 k events
 - ϕ angle is 0 : 12~13 k events
(a peak is at $\phi \sim 3^\circ$)
- 80% usage of 1 track events.
(no optimize)

Exclude myself from the track fitting



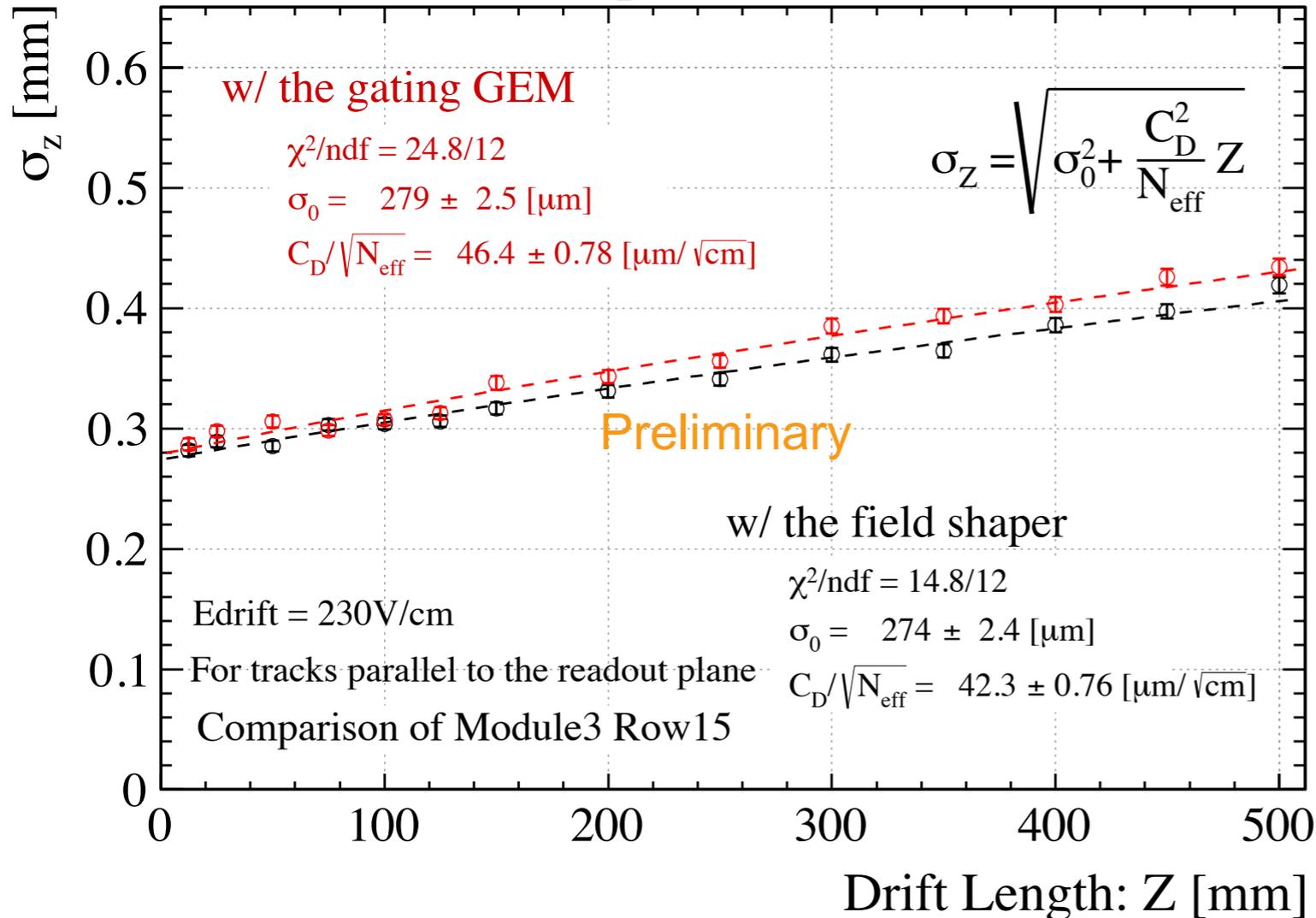
Z resolutions

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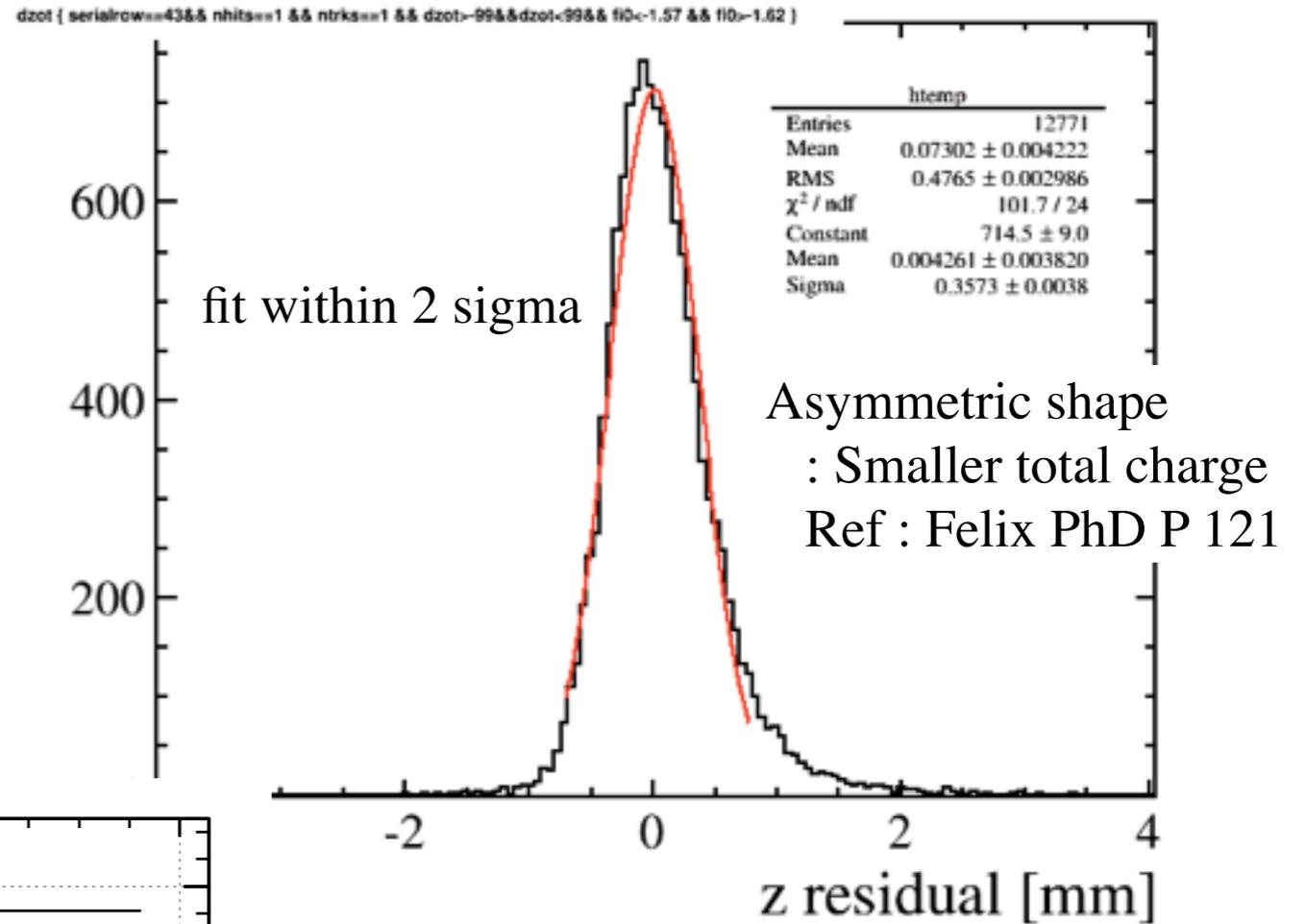
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(a peak is at $\phi \sim 3^\circ$)

→ 80% usage of 1 track events.
(no optimize)

Example Row 15



Exclude myself from the track fitting



○ Evaluated **N_{eff}** for 2 modules.

Ave. of the central (picked up) 20 rows.

- { the ion filter : **N_{eff} = 22.3 ± 0.7**
- { the field shaper: **N_{eff} = 27.0 ± 0.9**

(Fix longitudinal Cd=220 $\mu\text{m}/\sqrt{\text{cm}}$)

Ratio of the Ave. N_{eff} ~ 82.7 ± 3.8 %

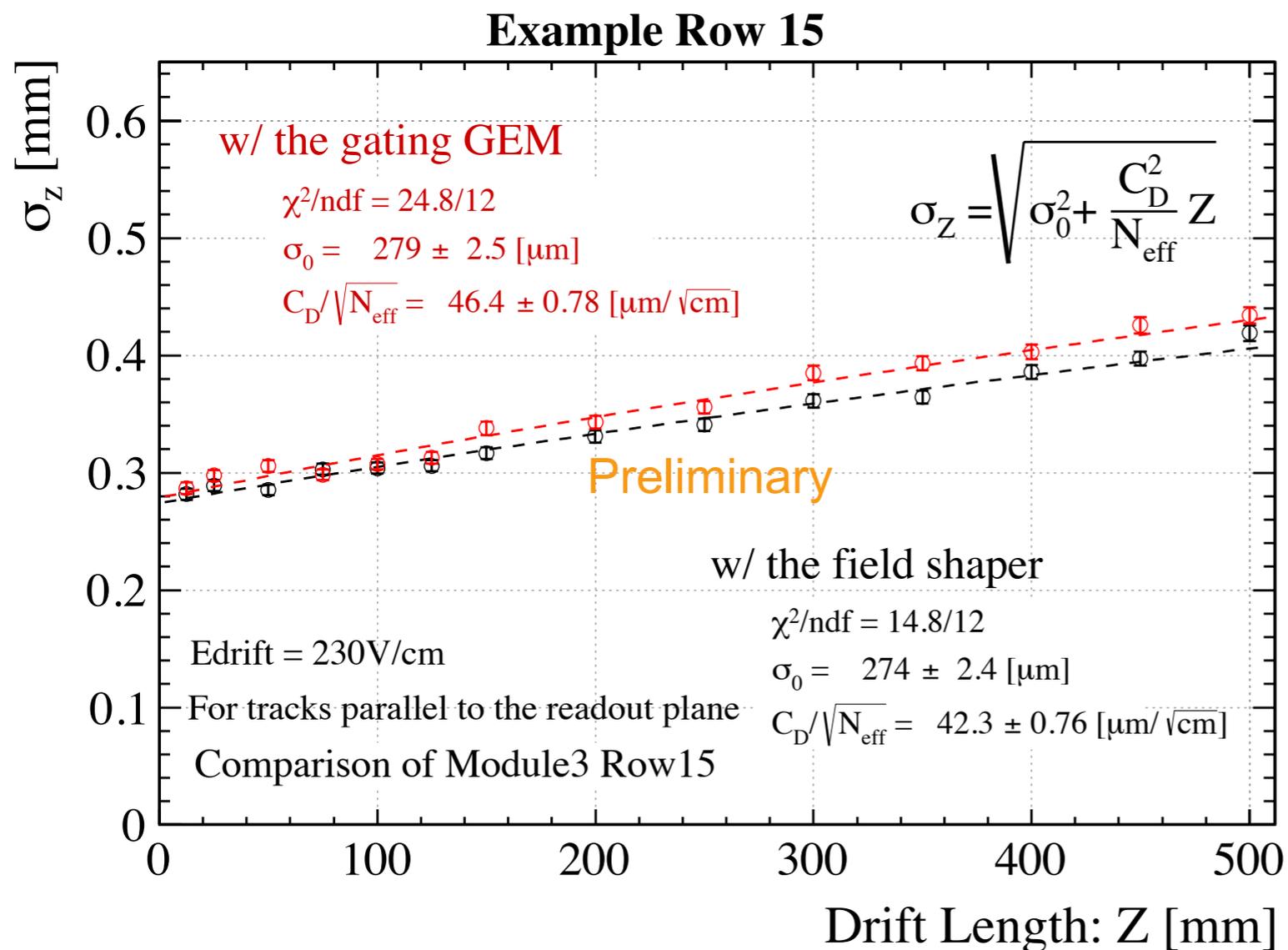
Z resolutions

○ **MIP scale** → Energy loss factor : **1/1.4** (HEED simulation)

○ **Resolution $\sigma_z \sim 865$ [μm]** with the full drift length of 2.2 m

Ave. σ_0 (w/ the gatingGEM) = 269.7

Up to here, already results were shown in IEEE17, so, may be no interest....



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Ratio of the **Ave. Neff** $\sim 82.7 \pm 3.8$ %

Simulation on Z resolution

Detailed Simulation of Large Prototype TPC
Testbeam Data

Astrid Münnich
DESY, Hamburg

September 29, 2014

<https://agenda.linearcollider.org/event/6783/>

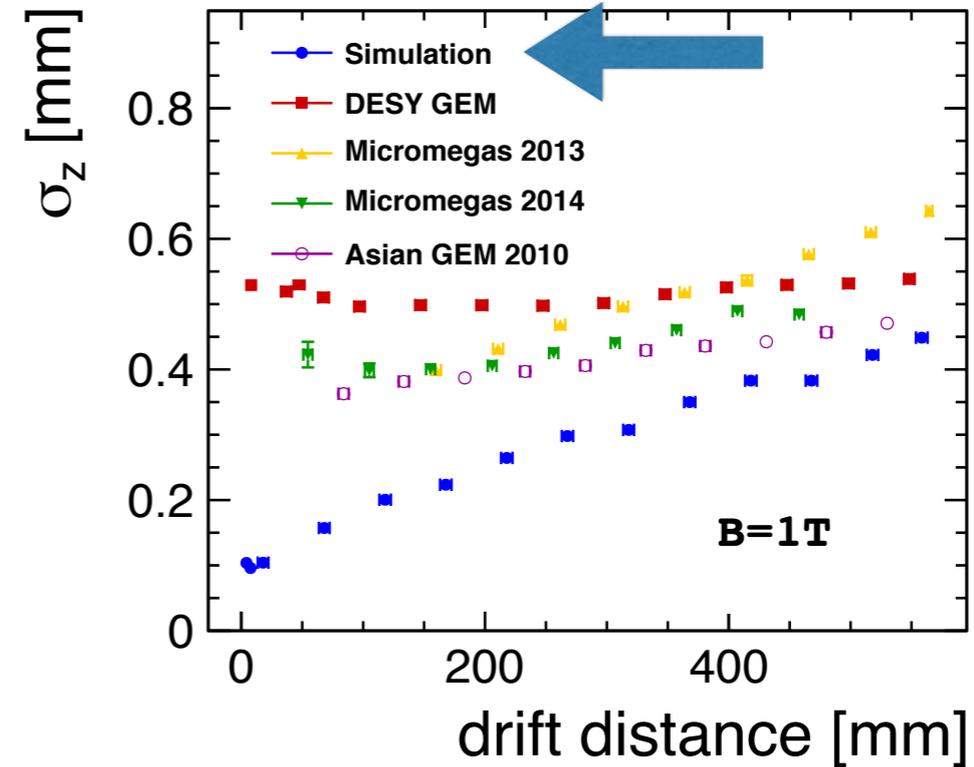
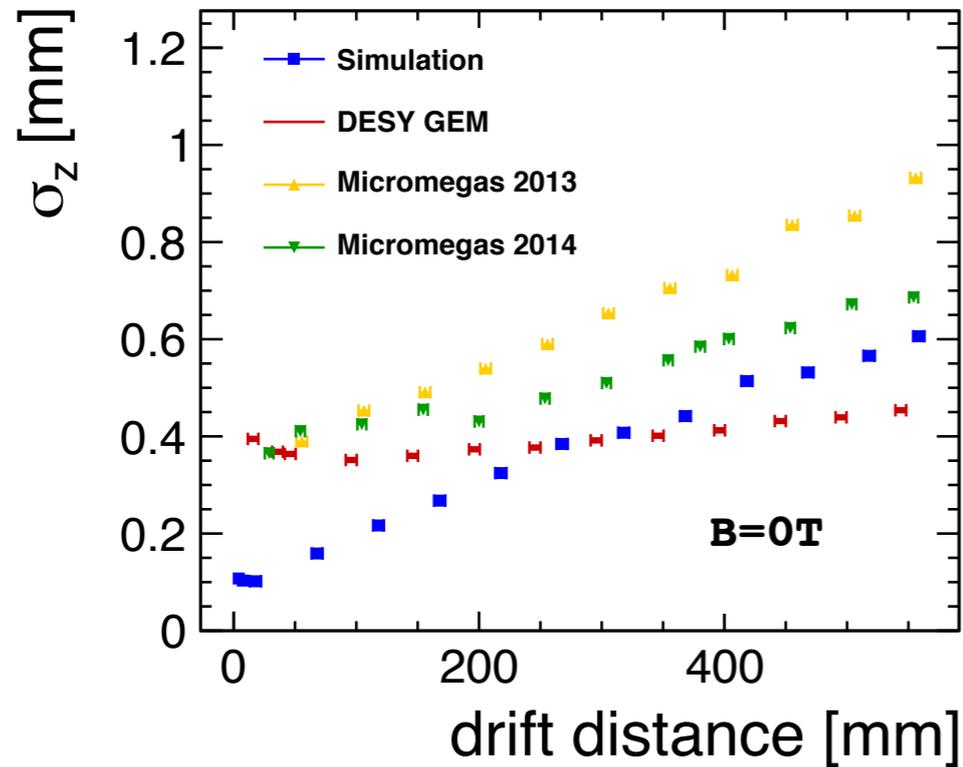


Figure 11: Single point resolution in the z direction for simulation and different data sets without magnetic field (left) and for 1 T (right).

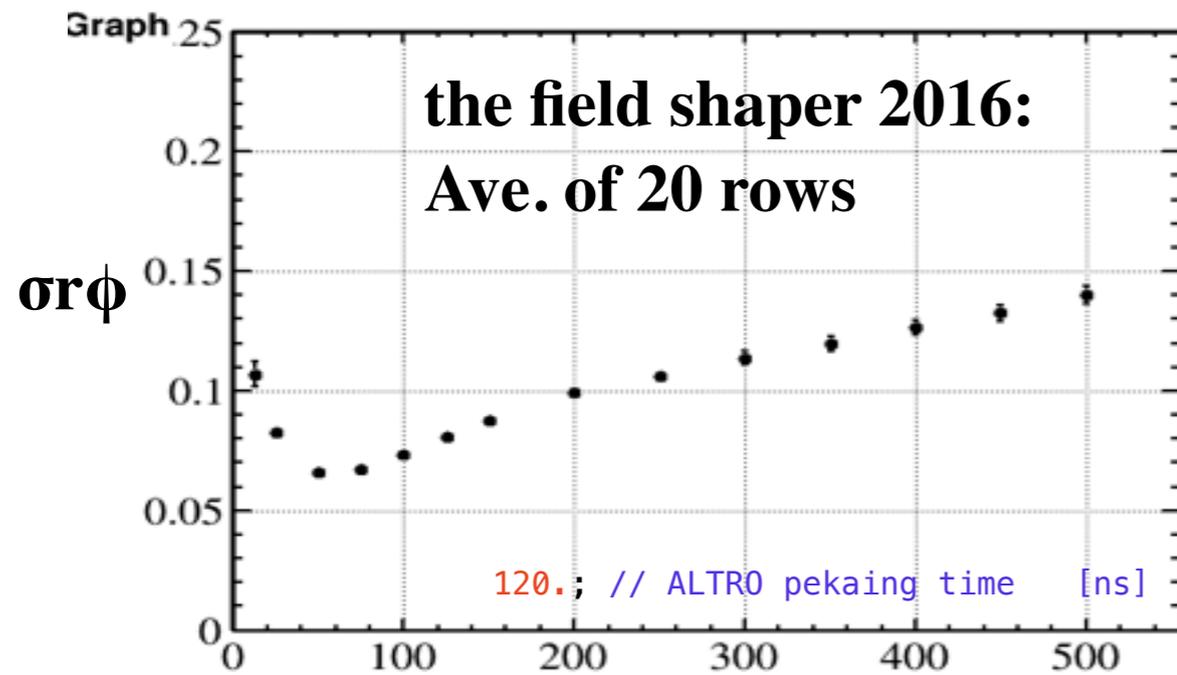
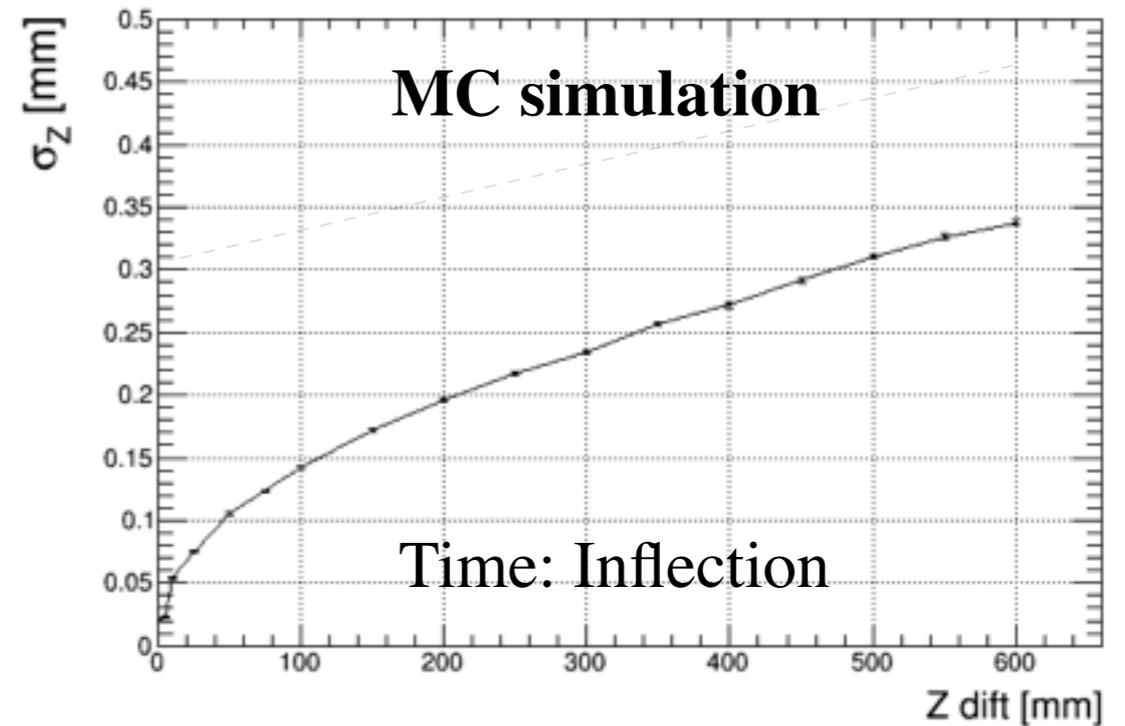
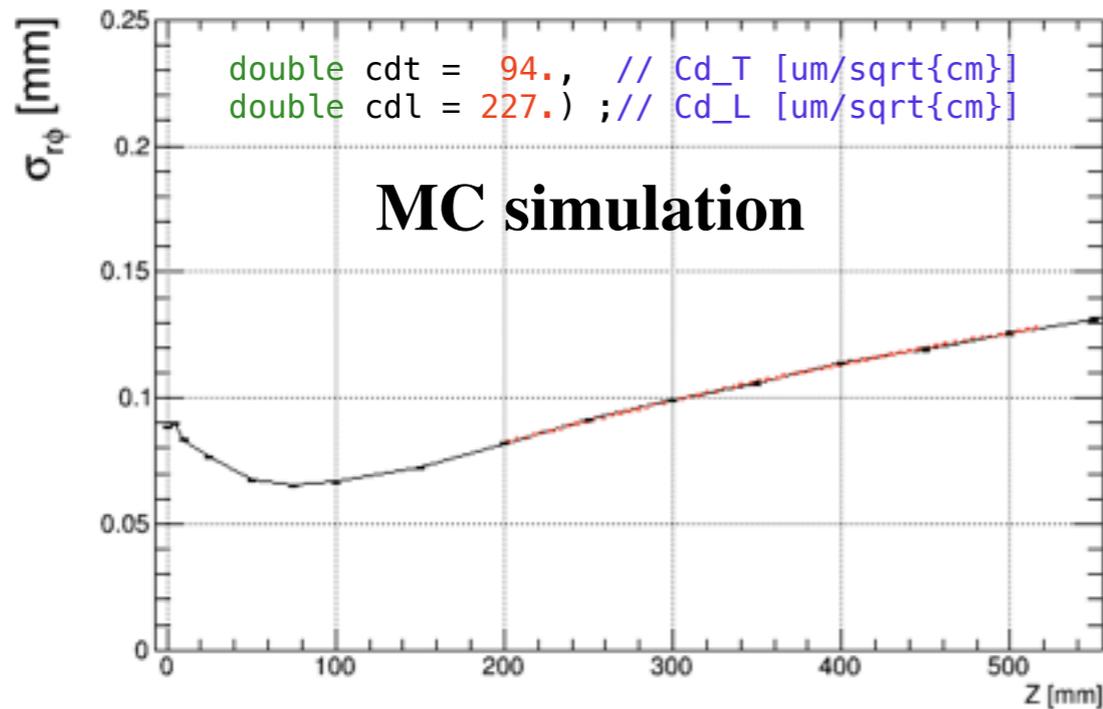
The large difference, She implies in her report,

We suspect that there is some part in the electronics that dominates over the fact that the charge is spread out in time,

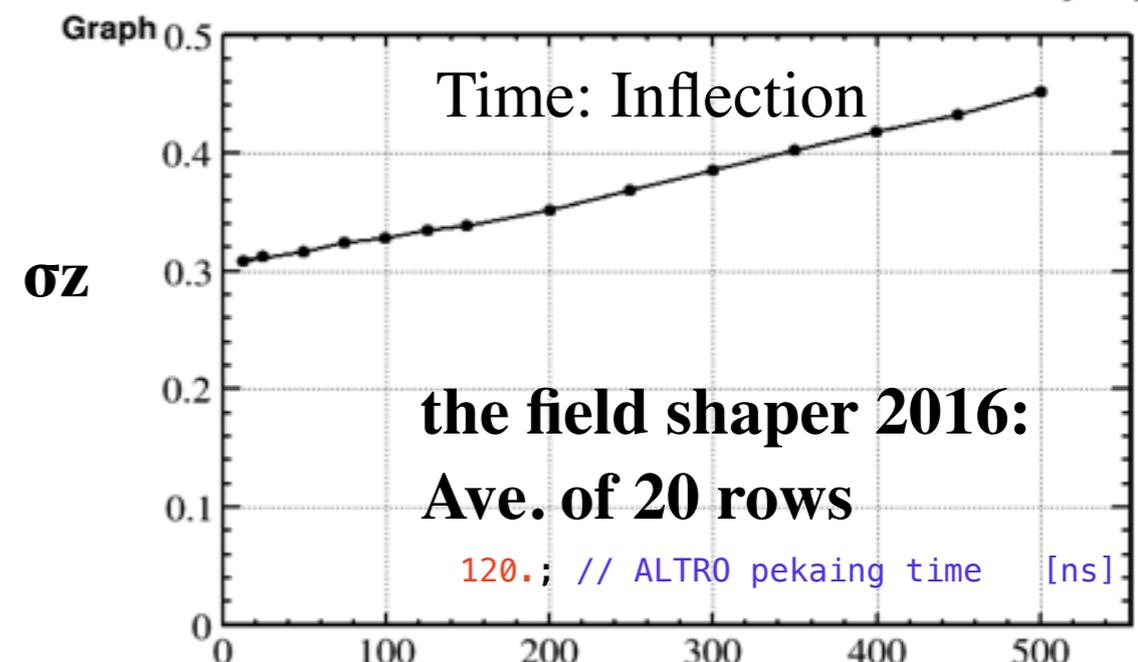
Simulation on Z resolution

Fujii-san has a private simulator for MPGD based TPC

```
// ----- PASA
const double tpk0 = 120.; // peaking time [ns]
const int n0 = 4; // shaper order
const double w0 = 50.; // time bin width [ns]
const double noise = 5.; // noise count
// ----- GEM
double sgprf = 0.27; // sigma_PRF [mm]
double wpad = 1.25; // pad pitch [mm]
double lpad = 5.20; // pad length [mm]
double len = 10.; // seg length [mm]
double nav = 30.; // <#primary ionizations>
double nav *= 1.4; // 5 GeV electron > MIP
double vd = 77.; // drift velocity [um/ns]
```



Good agreement



Bad agreement, what is it?

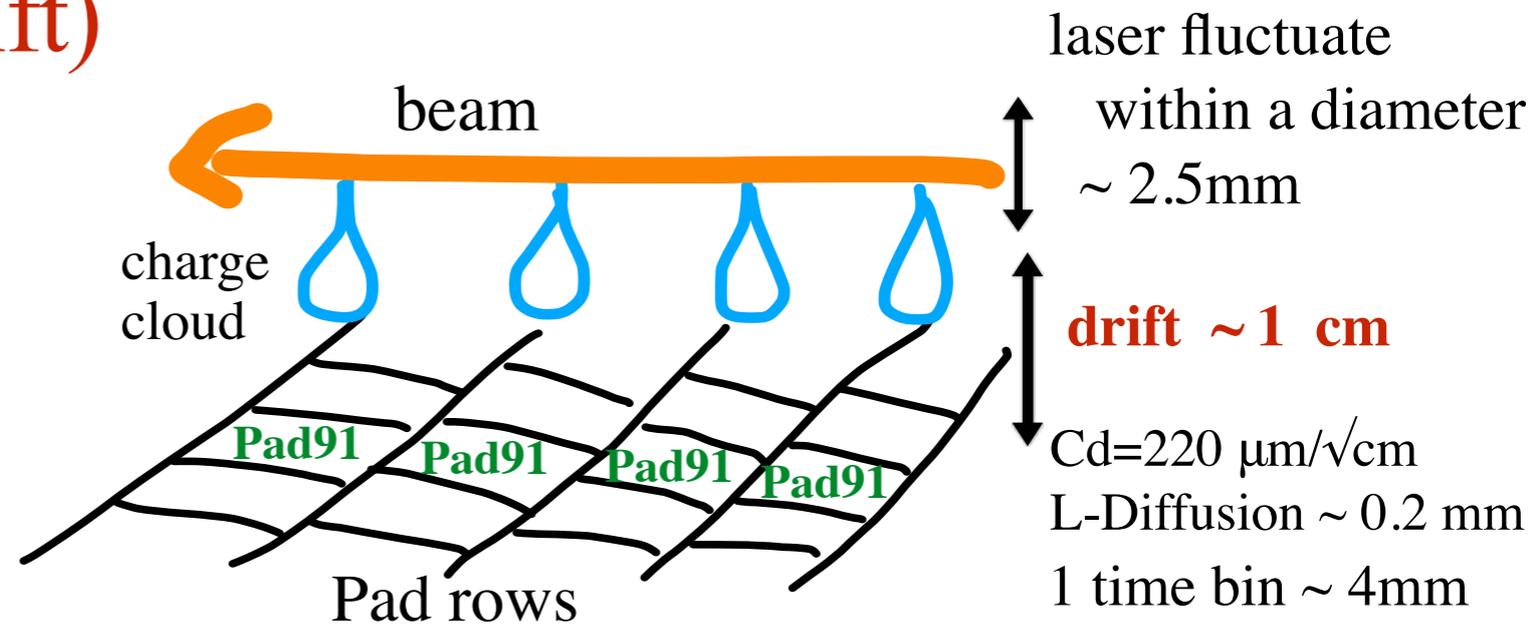
Cluster time (very short drift)

Our Lab. has ALTRO and Laser system

If every channels synchronously
start sampling, pulse time should be same

especially for very short drift data
and pads located in same pads.

Z of laser shot is same position
drift is extremely small ~ 1 cm



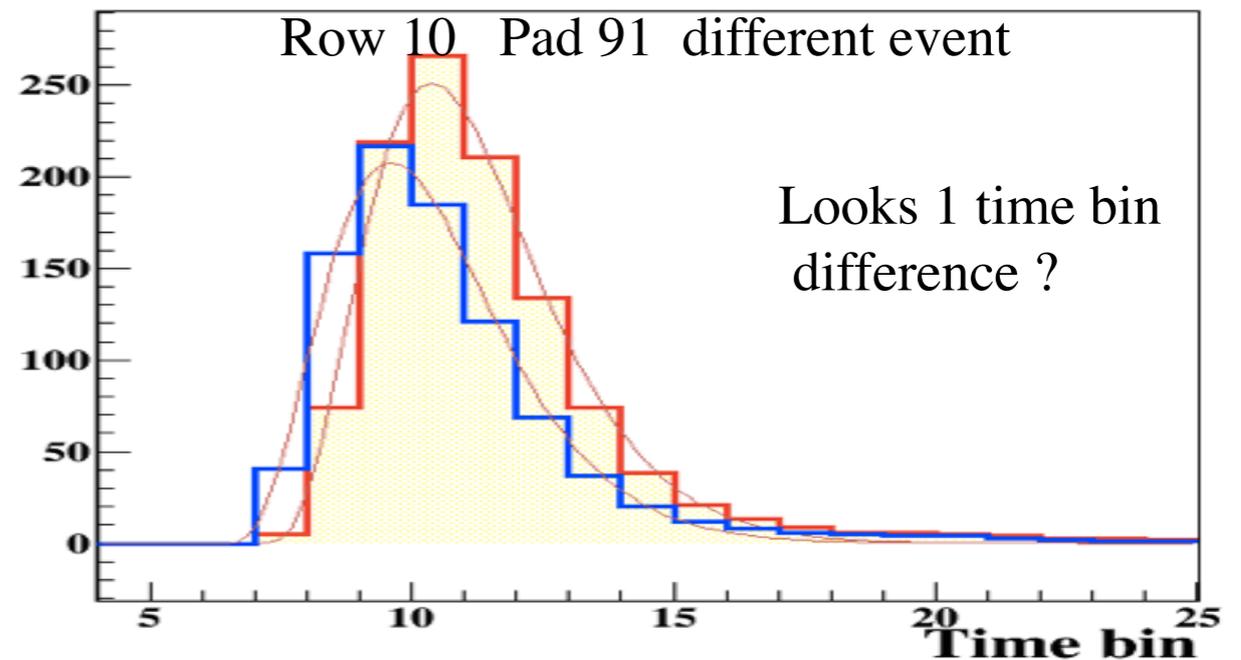
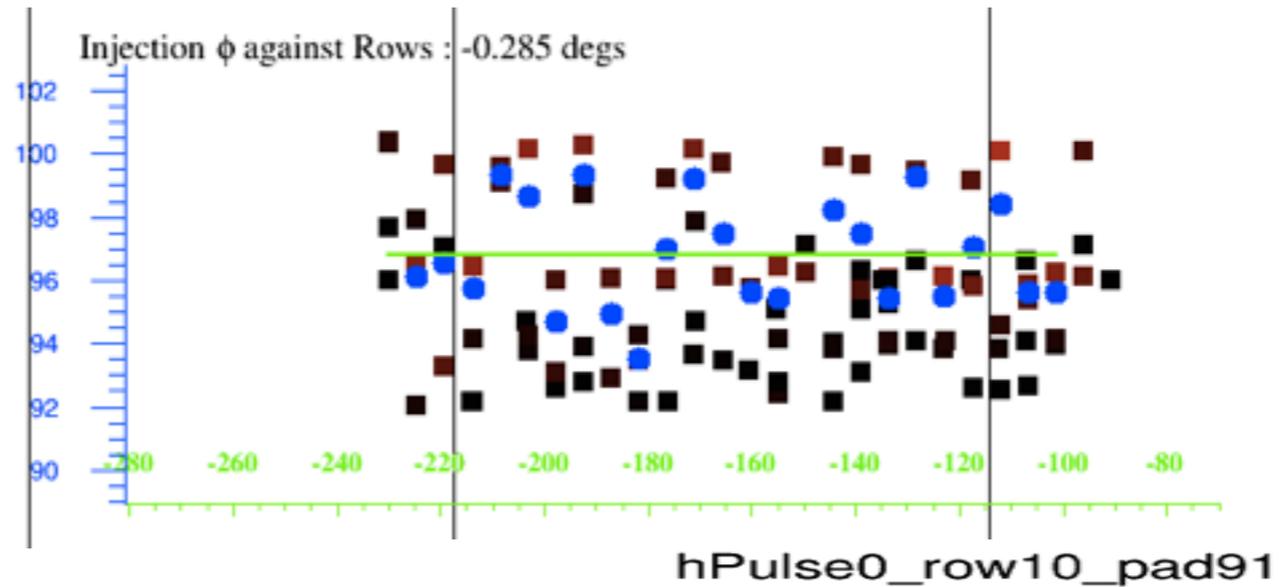
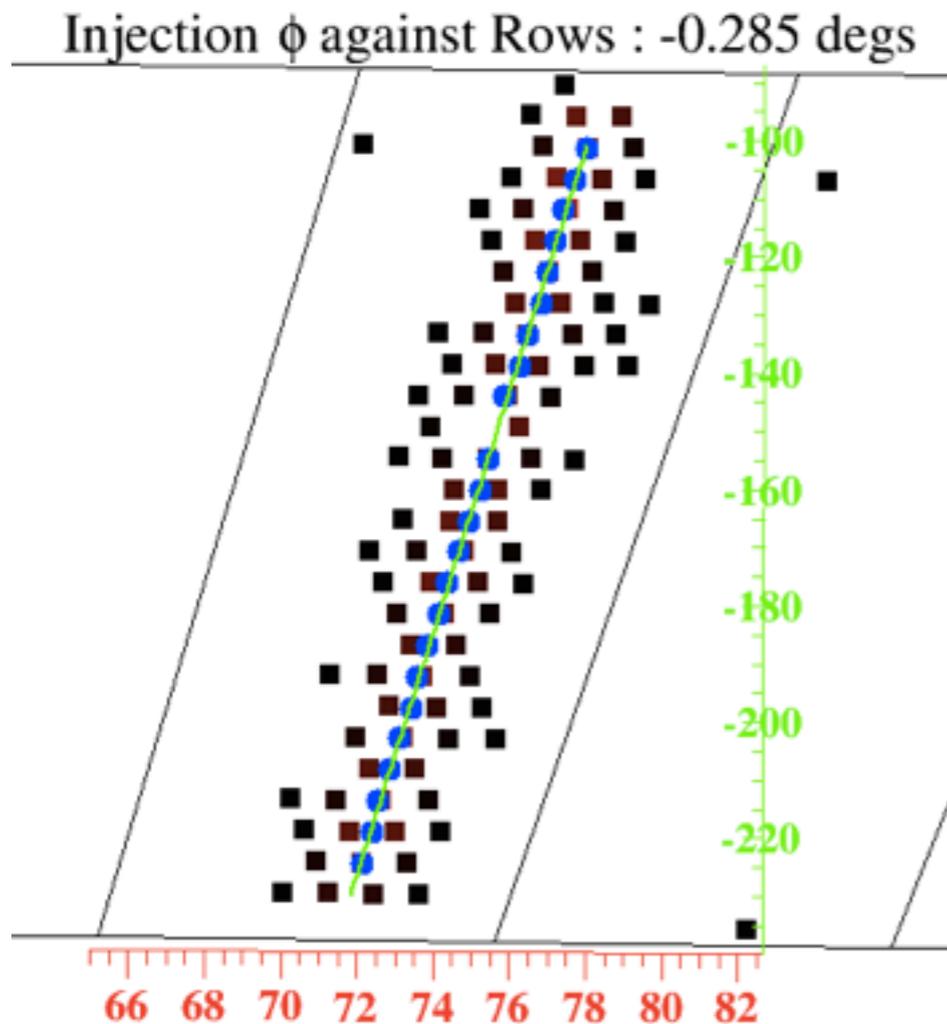
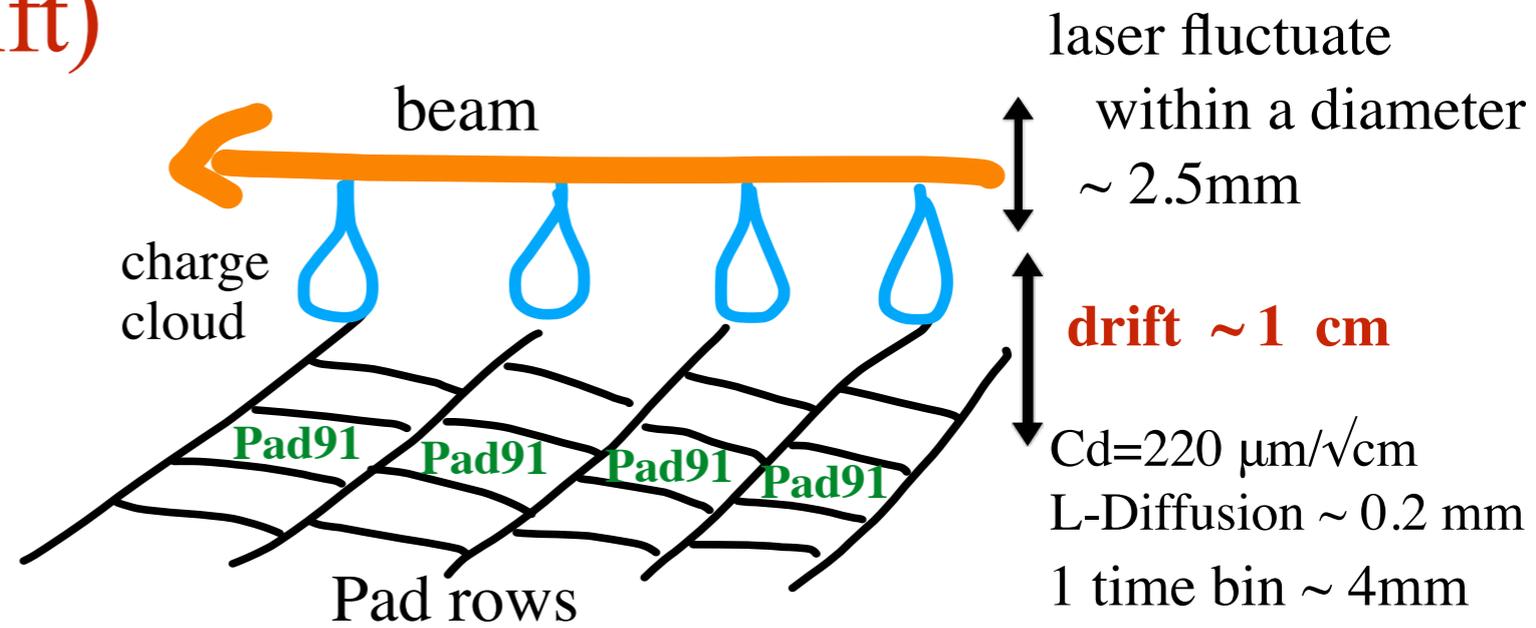
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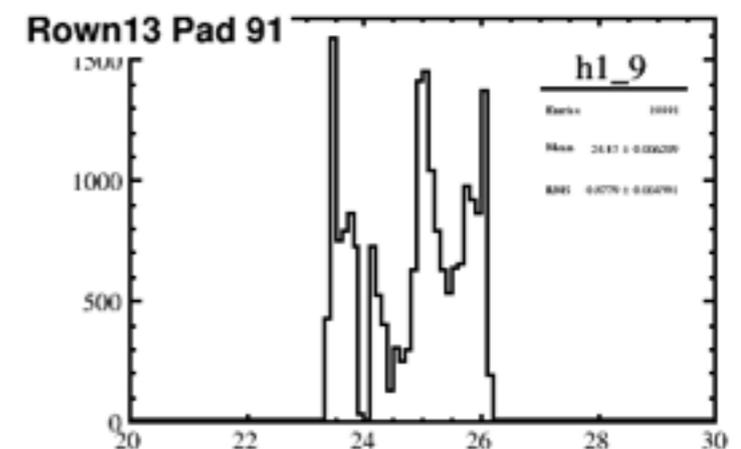
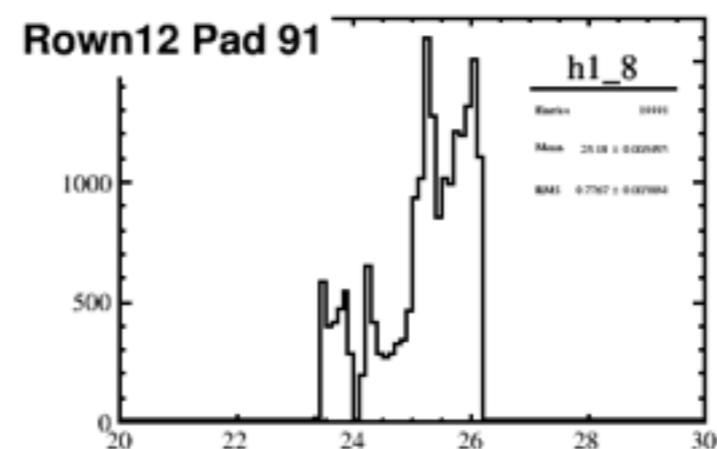
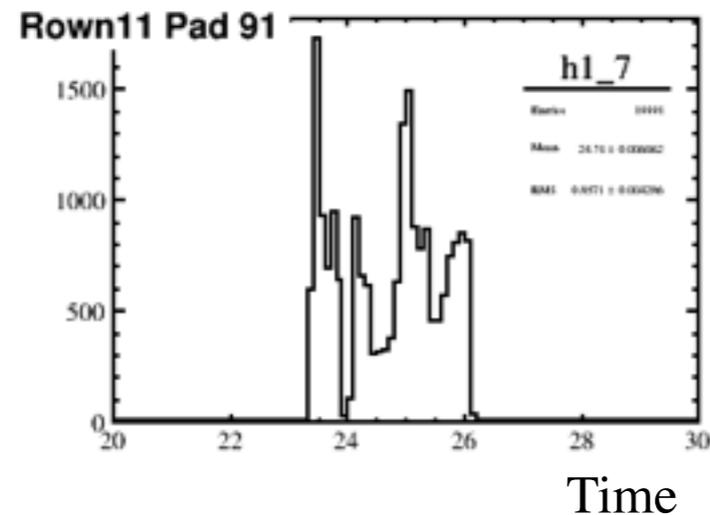
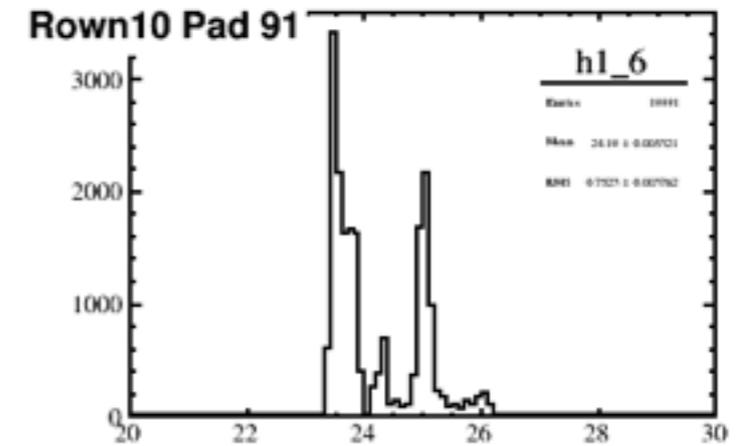
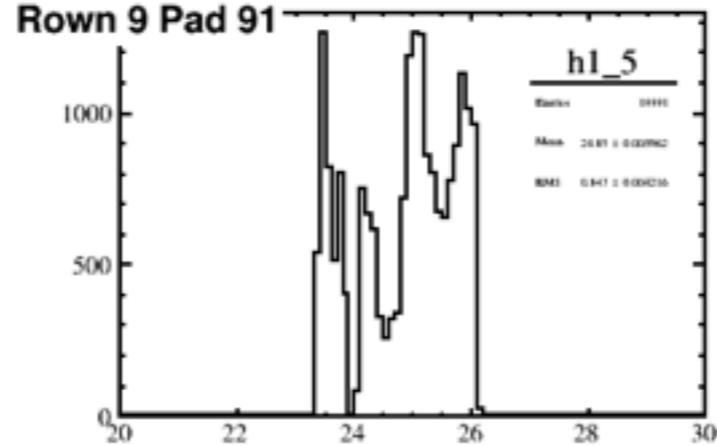
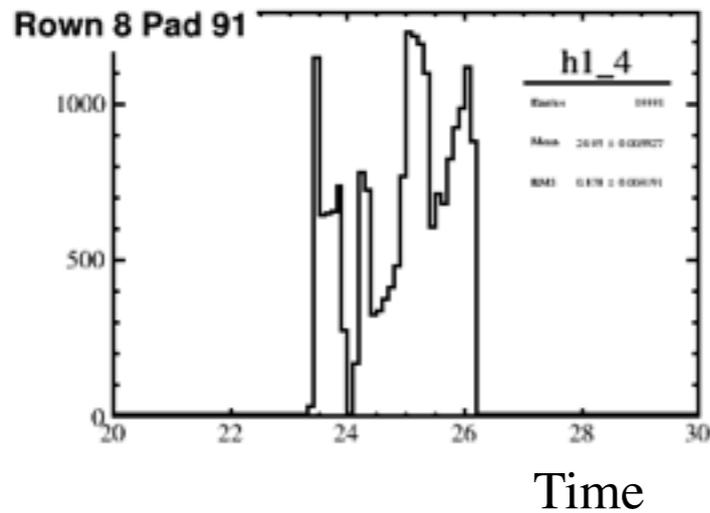
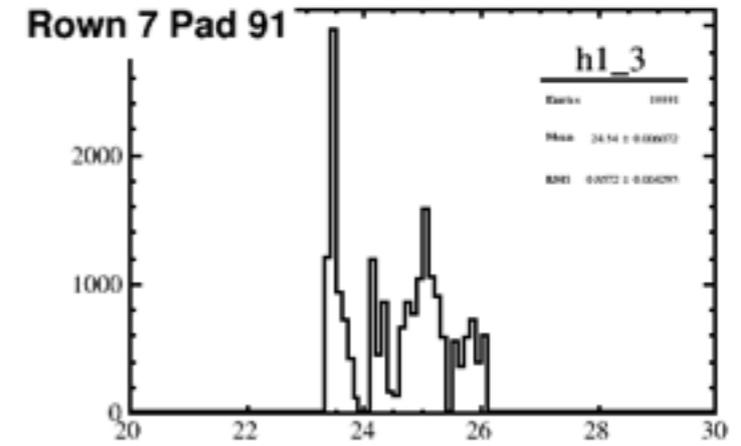
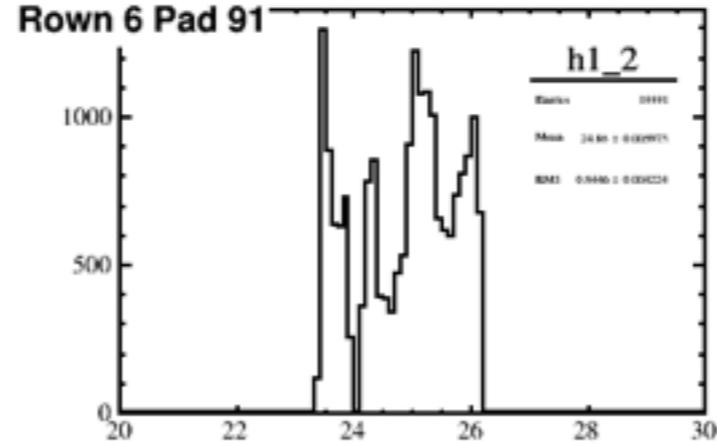
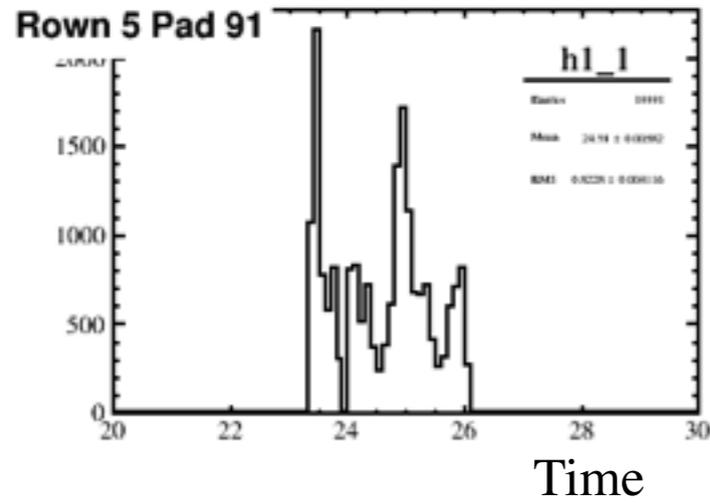
Z of laser shot is same position drift is extremely small ~ 1 cm



Cluster time (very short drift)

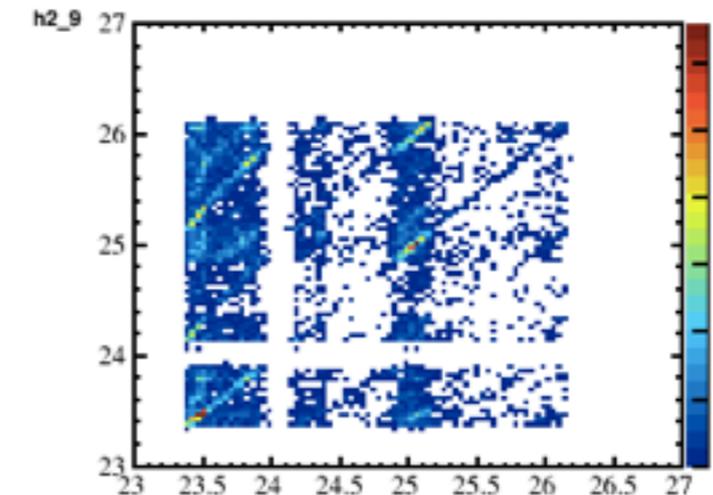
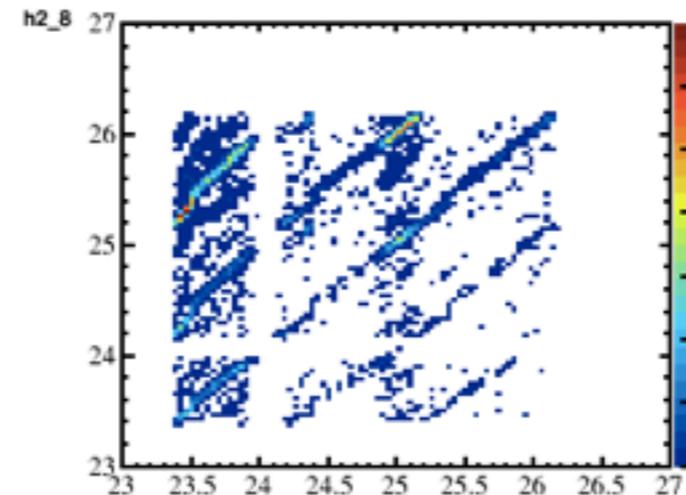
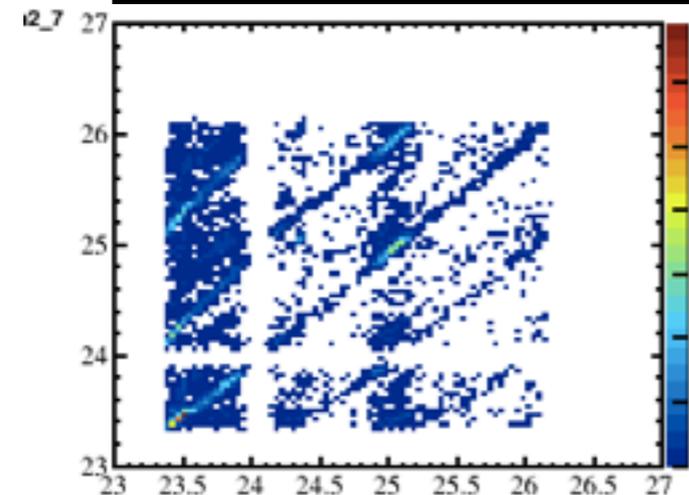
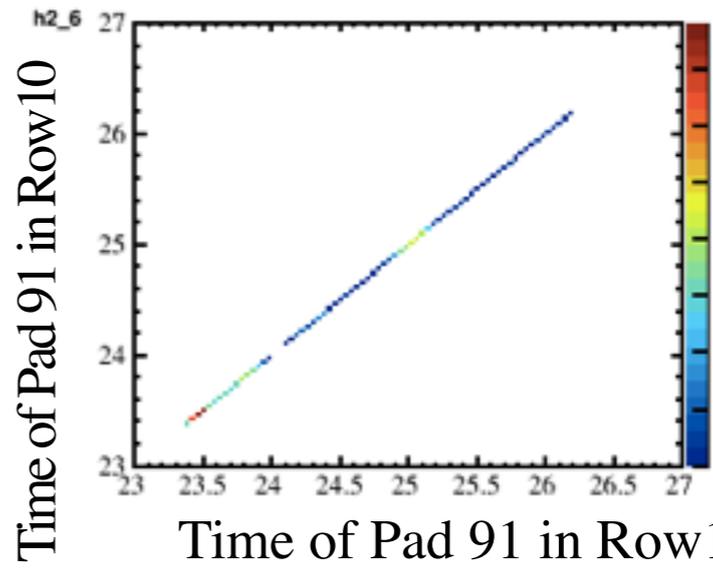
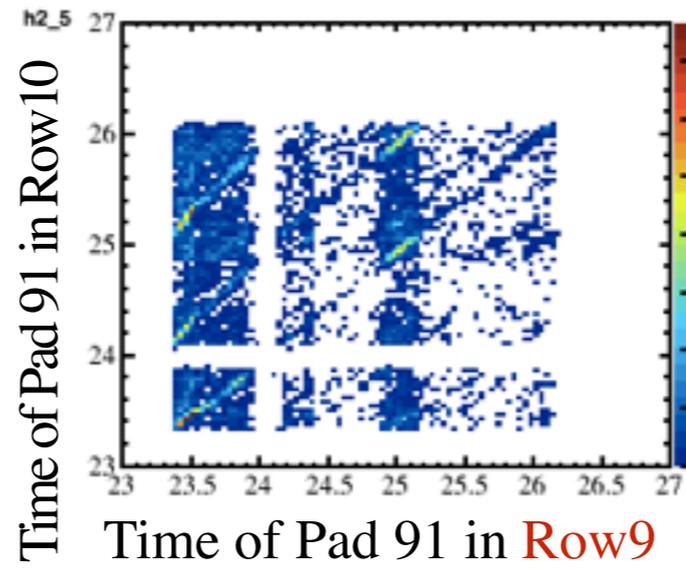
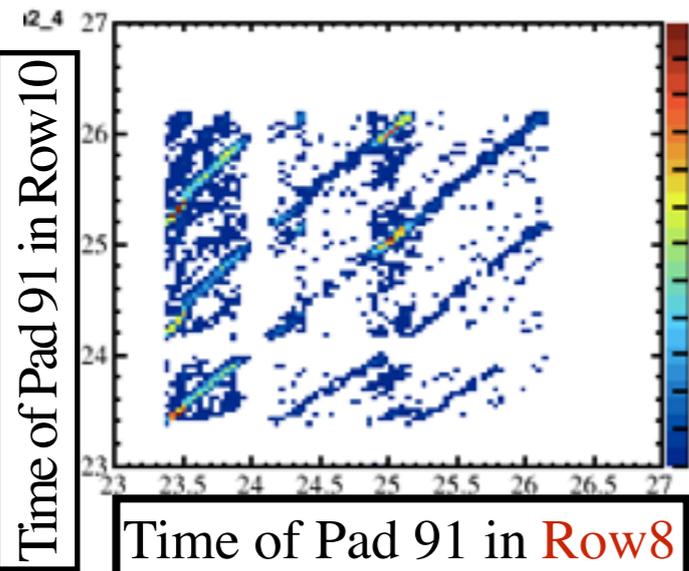
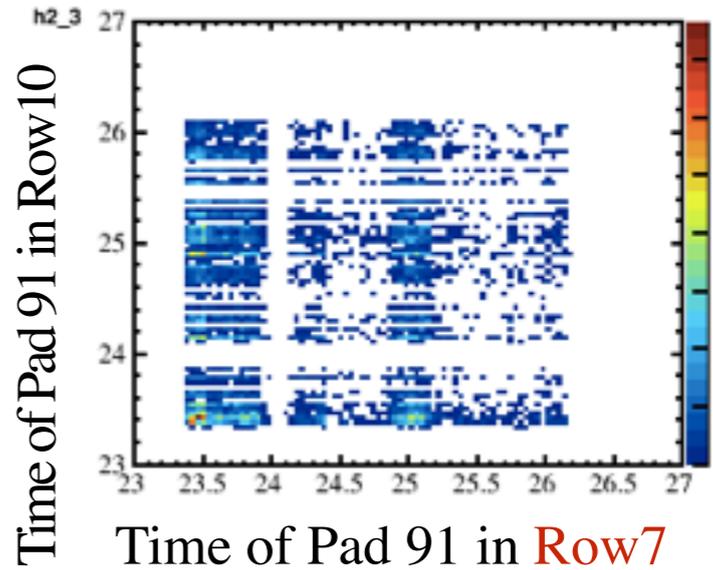
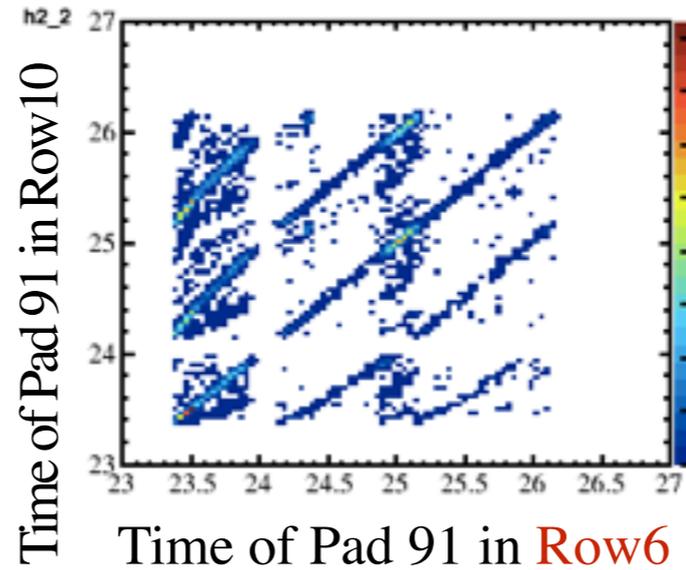
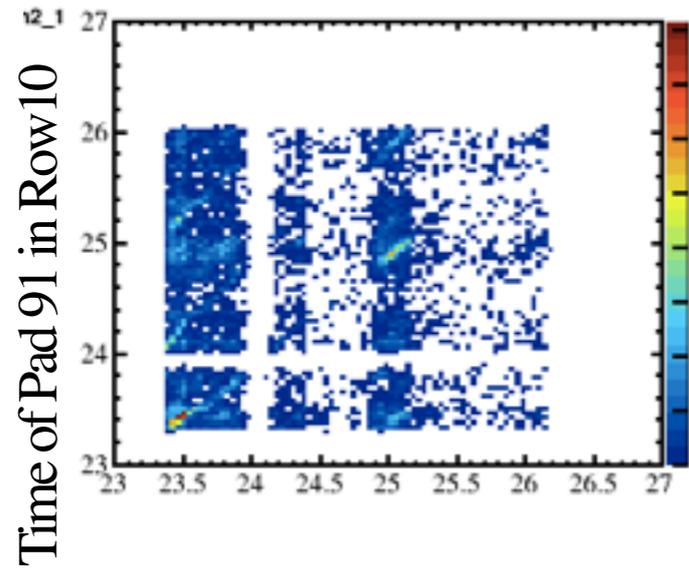
24 * 50 ns * 77 mm/ns
92.4 mm
unit is 10 times difference ?

Cluster Time distribution of Pad 91 in each row
Time Estimator : Inflection Point



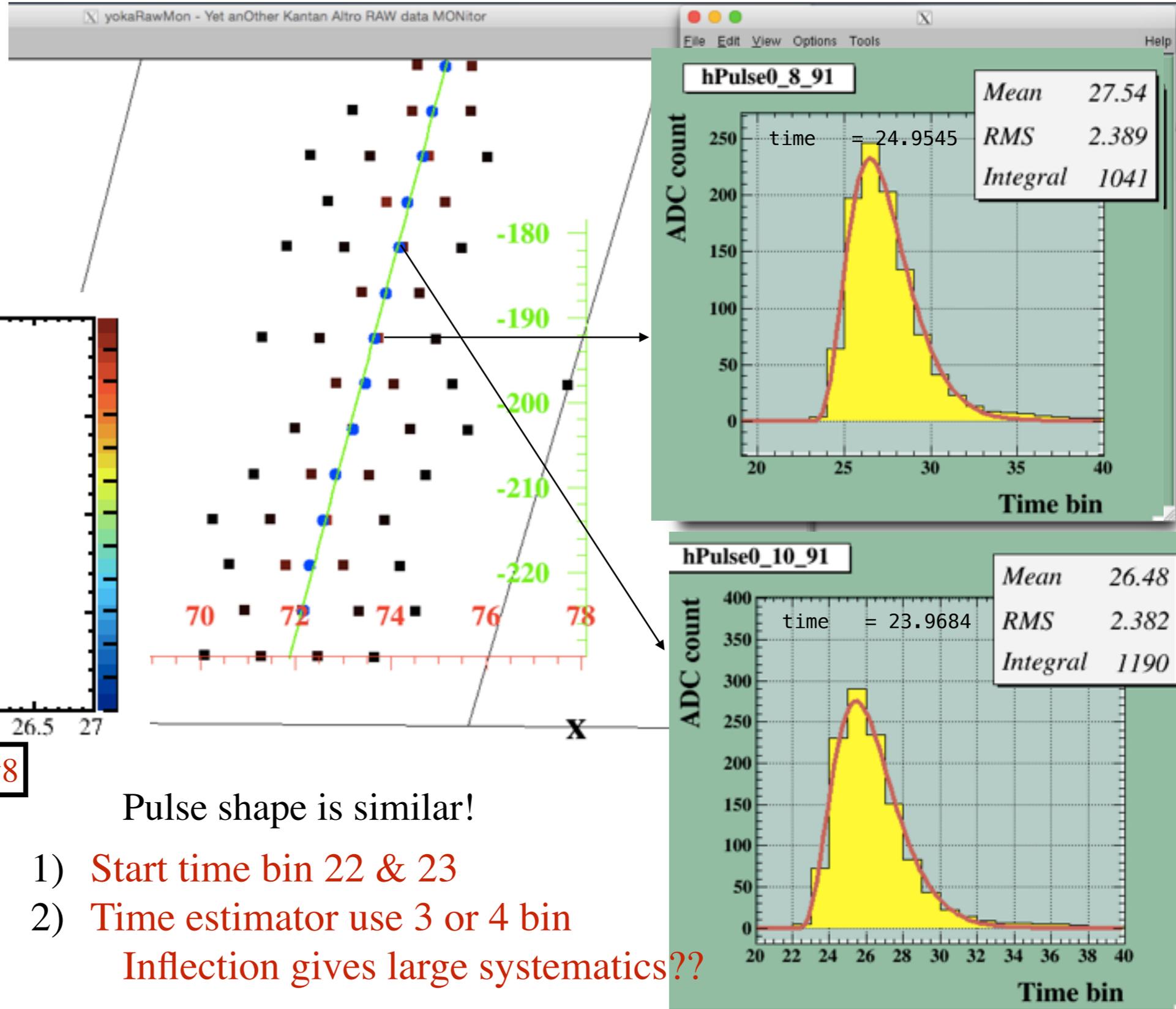
Cluster time (very short drift)

Cluster Time distribution against Pad 91 in Row10



Pick up Specific event & Check Row pulse

Time of Pad 91 in Row8



Pulse shape is similar!

- 1) Start time bin 22 & 23
- 2) Time estimator use 3 or 4 bin
Inflection gives large systematics??

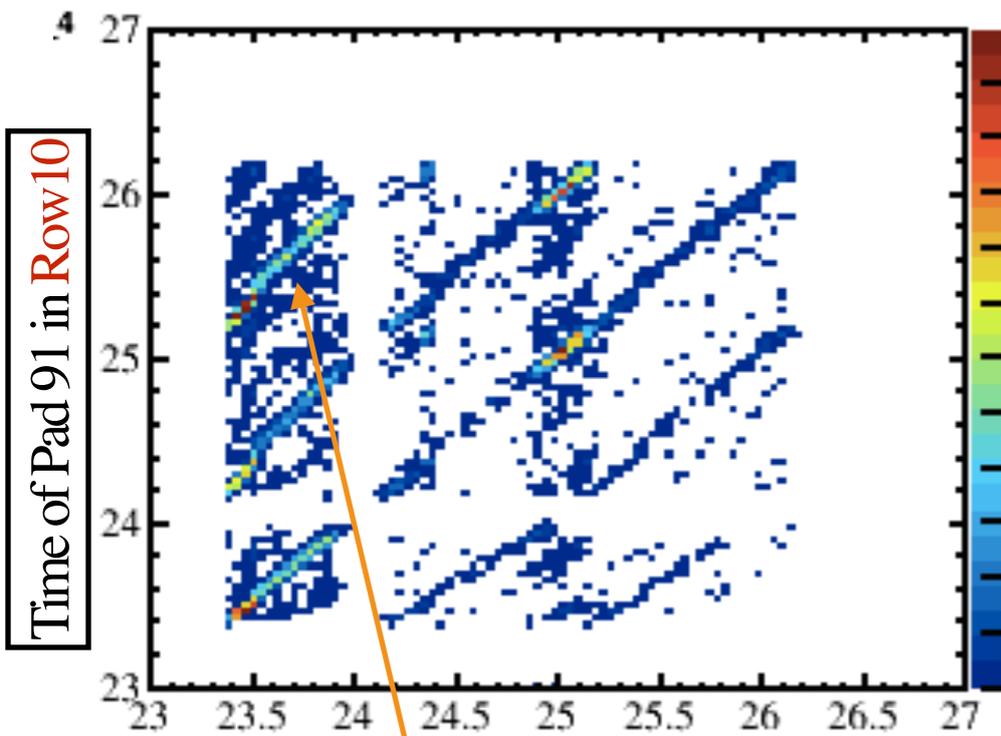
Event 550

Time of Pad 91 in Row8

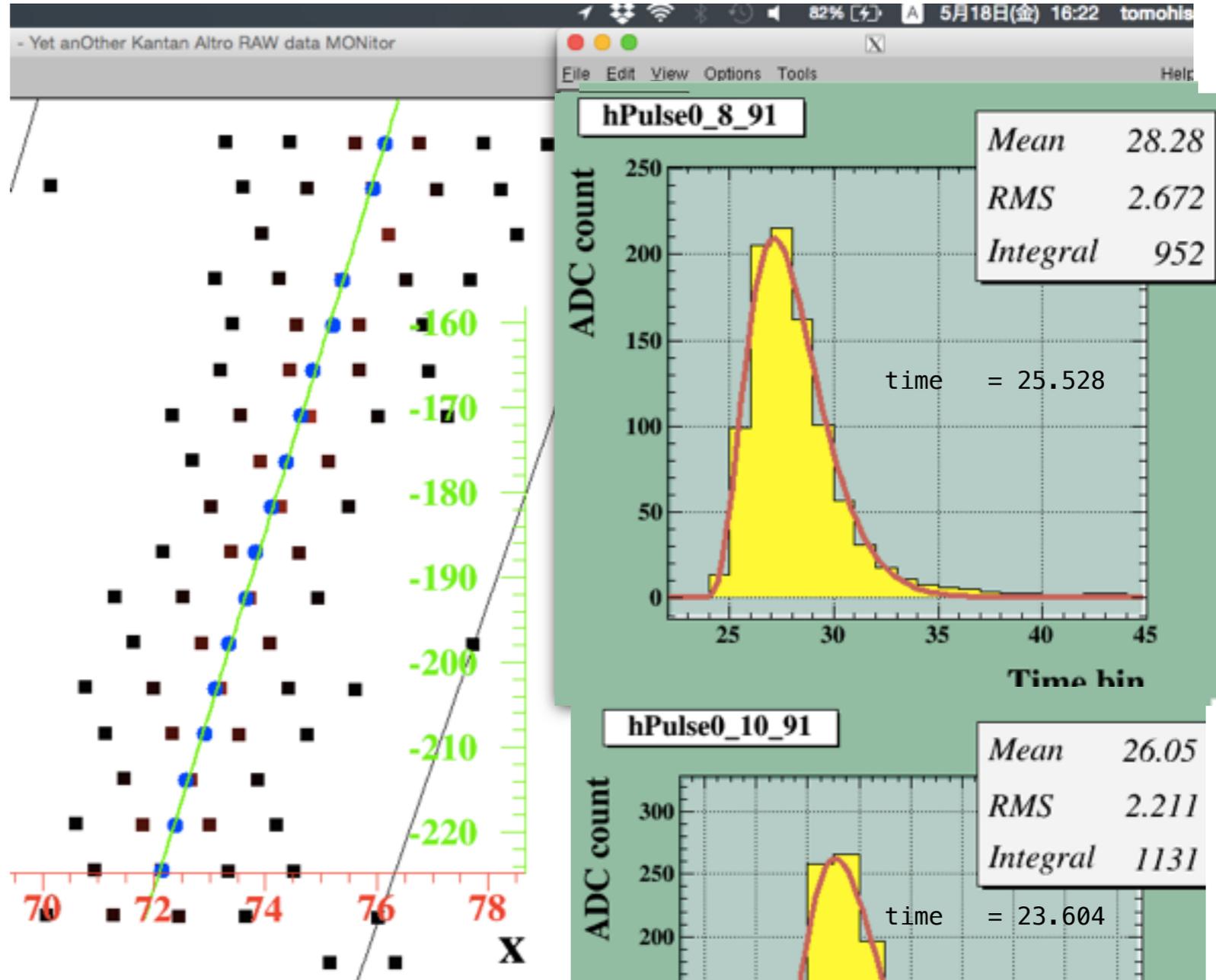
Time of Pad 91 in Row10

Pick up Specific event & Check Row pulse

Time of Pad 91 in Row8



Event548



Pulse shape is similar!

- 1) Start time bin 22 & 24
- 2) Time estimator use 3 or 4 bin
Inflection gives large systematics??

- 1) Time Estimator use only 3 bins sometimes, is it OK?
- 2) Electronics unsync. at least 1 time packets?

Need to check beam test data!

Time of Pad 91 in Row10

Simulation on Z resolution

Trial !

Artificially, randomly,
I include the effects of
1time bin shift in the simulation.

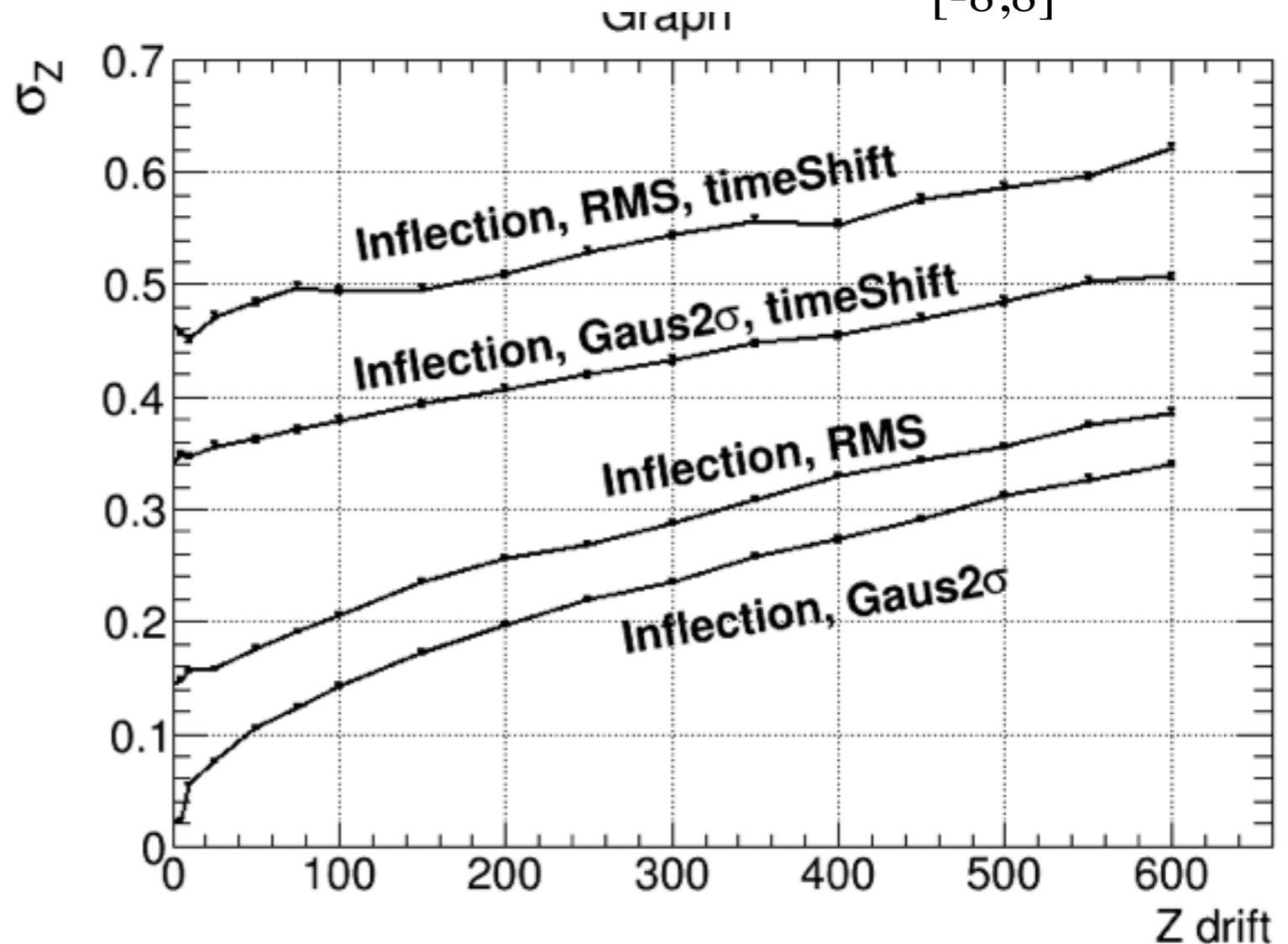
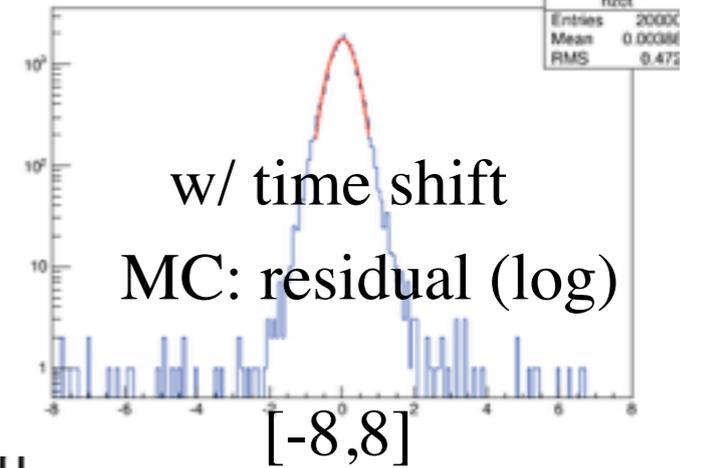
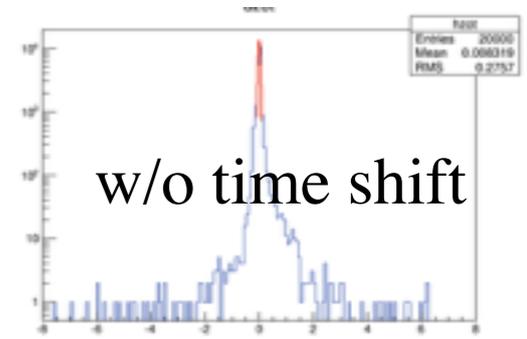
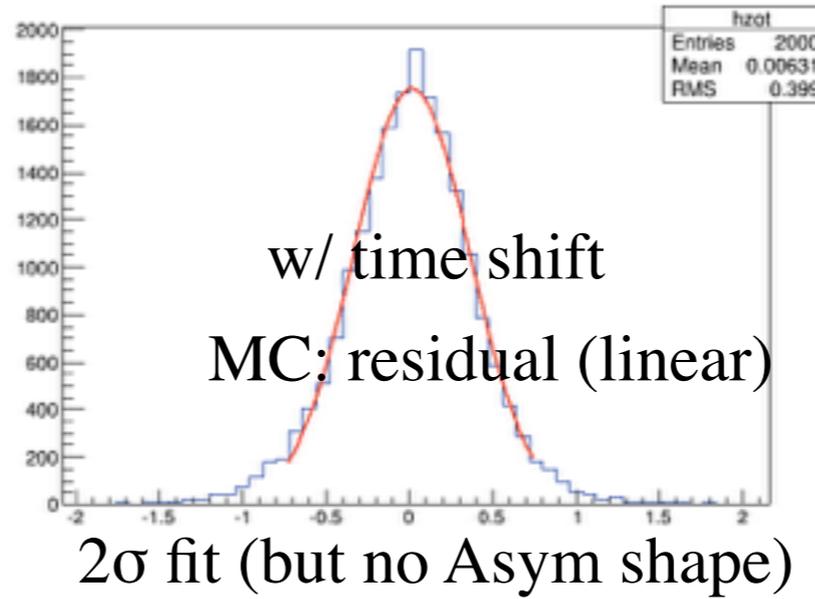
```
int shiftBin = 0.5>gRandom->Uniform(1.) ? 1:0;
```

Time: Inflection

Resolution: Gaus 2 sigma fit

RMS of distributions [-8,8]

Z Residual on certain Row

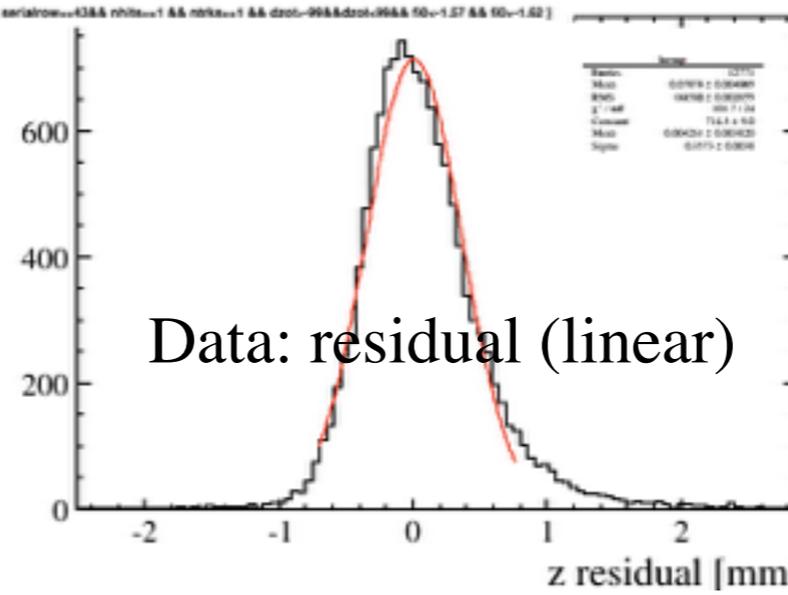


Simulation on Z resolution

Z Residual on Row 15 (field shaper)

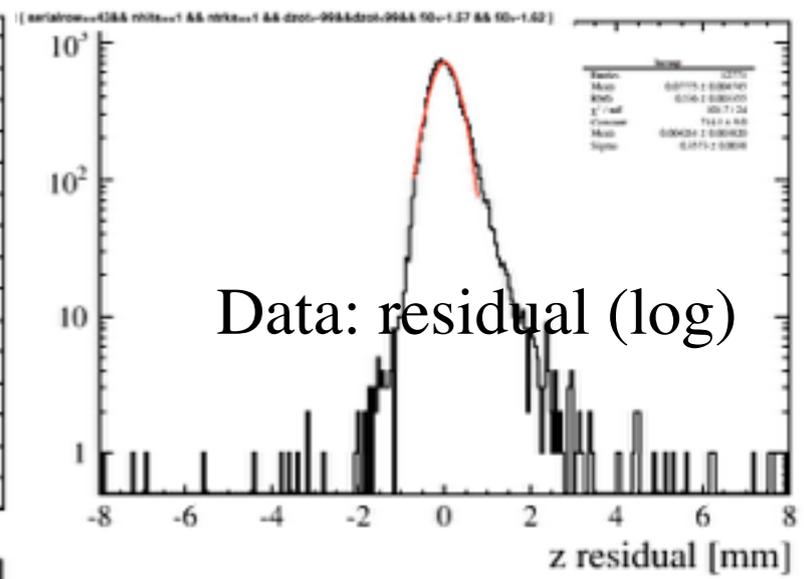
Artificially, randomly,
I include the effects of
1time bin shift in the simulation.

```
int shiftBin = 0.5>gRandom->Uniform(1.) ? 1:0;
```



Data: residual (linear)

2 σ fit (but Asym shape)



Data: residual (log)

[-8,8]

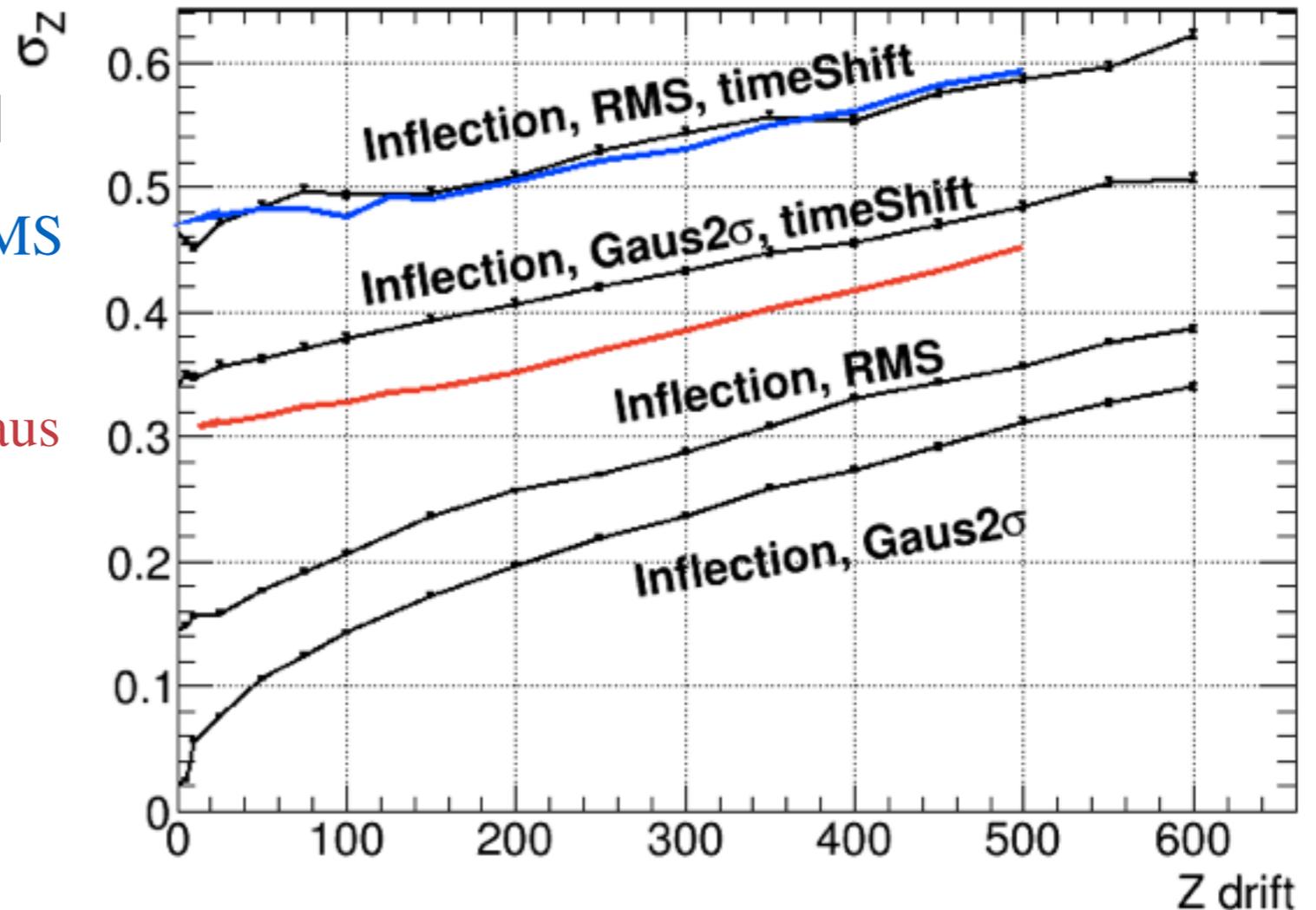
Time: Inflection

Resolution: Gaus 2 sigma fit
RMS of distributions [-8,8]

2016 Data : Ave. 20Row RMS

2016 Data : Ave. 20Row Gaus
(residual is Asym)

ACCIDENTALLY ?



Summary

- Rough view for Z resolutions using 2016 beam data

Ratio of the **Ave. Neff** $\sim 82.7 \pm 3.8 \%$ which is expectation for the aperture

- **Resolution $\sigma_z \sim 865 [\mu\text{m}]$** with the full drift length of 2.2 m
Ave. σ_0 (w/ the gating GEM) = 269.7

- Simulation on behavior of the Z resolution (very personal opinion)

Astrid implied,

there is some part in the electronics that dominates over the fact that the charge is spread out in time,

The result I showed is just ACCIDENT?

Question to LCTPC

Q1). Are sampling clocks really synchronized among channels?

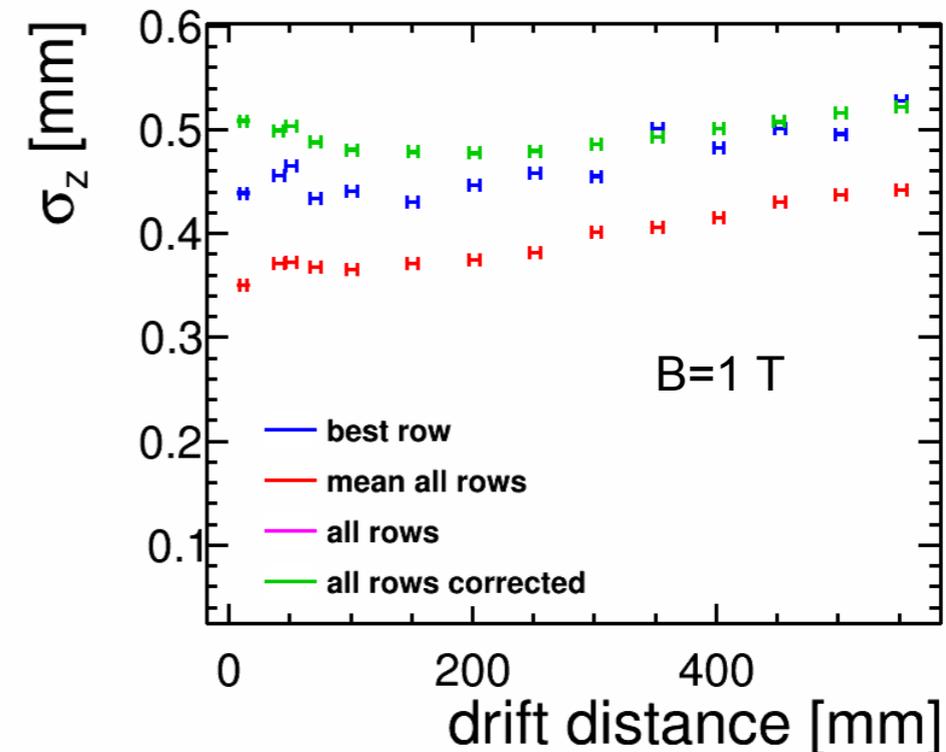
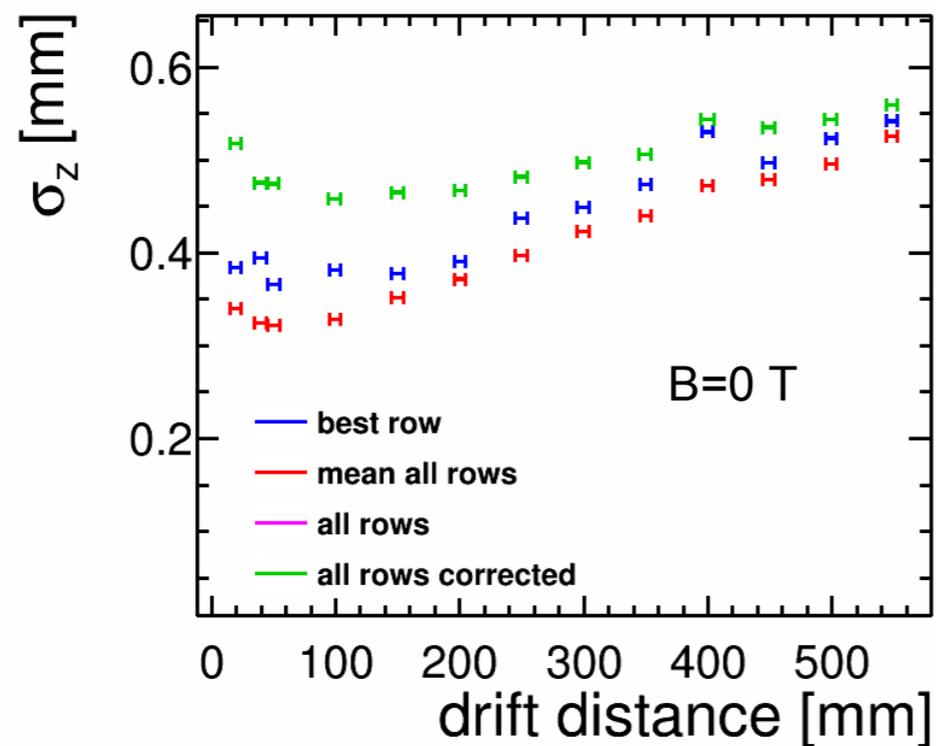
Can any ALTRO users prove it using ALTRO?

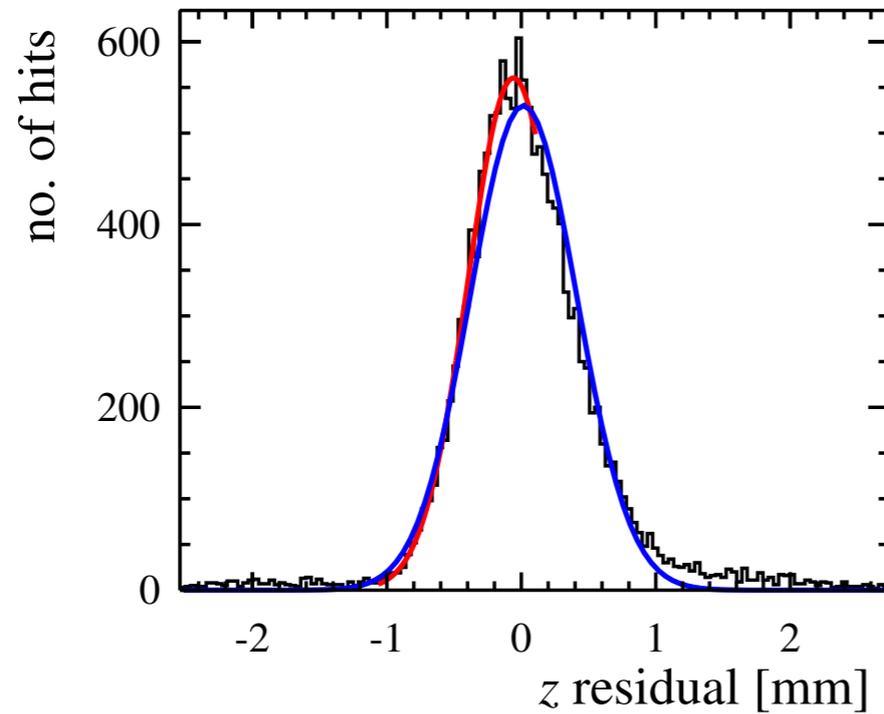
Q2). The method “Inflection point” works well?

Better to re-think the time estimator?

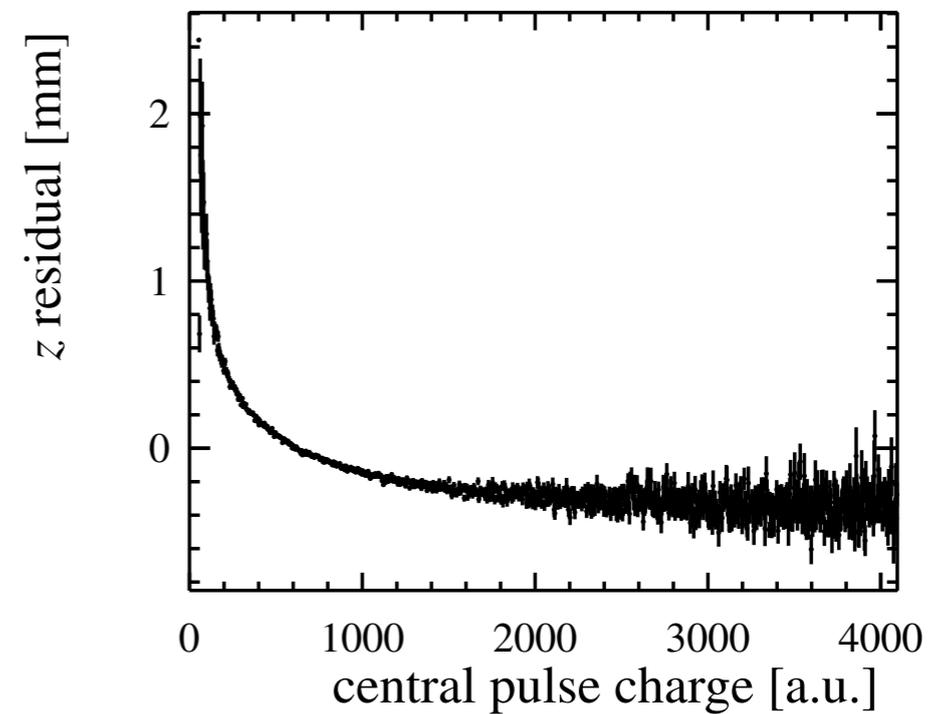
Z Resolution

- The overall resolution drops but the main systematic is still the same
 - Larger rise for 0T data than for 1T data
 - Slightly worse σ_0 for 1T data
- What N_{eff} is expected for z resolution? Same as for $r\phi$ resolution?





(a) exemplary residual distribution



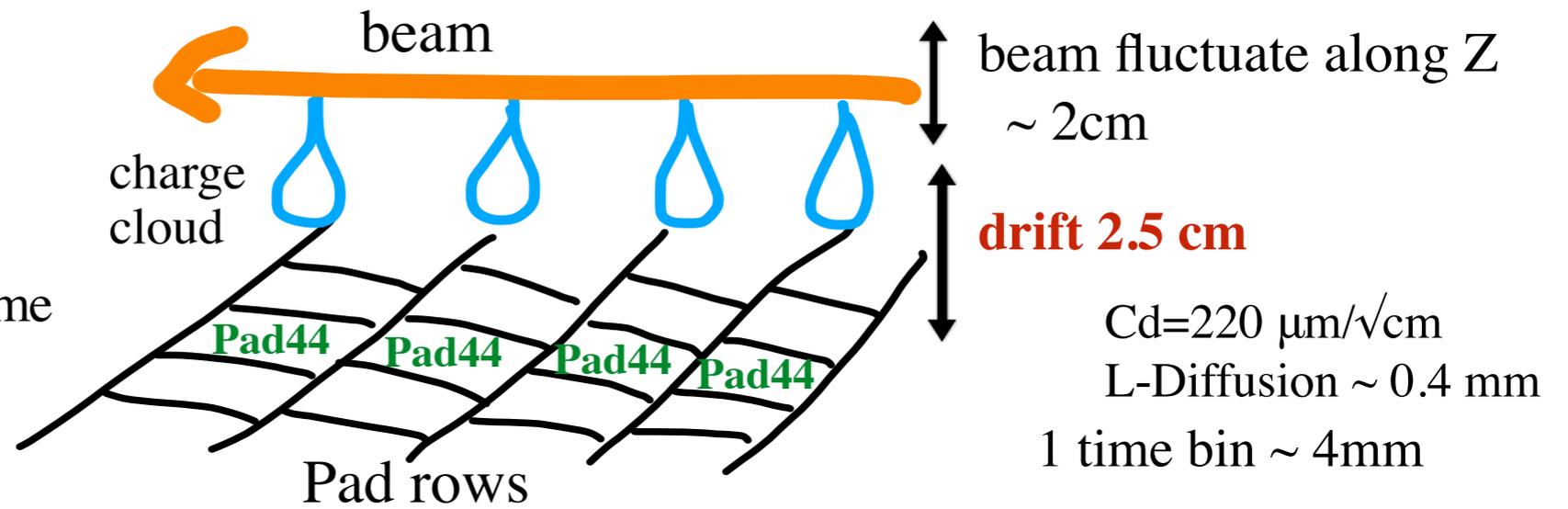
(b) charge dependence of the time estimation

Figure 6.31: a) Example z -residual distribution of one measurement run. A Gaussian fit over the full range and only the left side of the distribution is shown in blue and red, respectively. b) Charge dependence of the time estimation. Smaller total charge of the pulses bias the time estimation to longer drift distances. Therefore, an asymmetric residual distribution in the z direction is observed in figure a). The width of the limited fit serves as input to the resolution estimation using the geometric mean method.

A first look into the longitudinal residual distribution reveals that the expected Gaussian distribution is skewed towards larger values. One example residual distribution is displayed in figure 6.31a. The skewness of the distribution can be explained by the charge dependence of the longitudinal residuals which it is depicted in figure 6.31b. A charge dependence of the time estimation is a typical issue if a constant threshold is used for the time determination. This effect is called timewalk. However, the Gaussian inflexion point method should not suffer from a time walk effect. The other possible explanation could be a non linear response of the readout electronics. Unfortunately, a test bench for the electronics is not available and the hypothesis cannot be verified in the scope of this thesis. In principle, the charge dependence can be extracted from the measured data and applied as a correction. This correction procedure is currently being studied in depth. However, the left hand side of the residual distribution

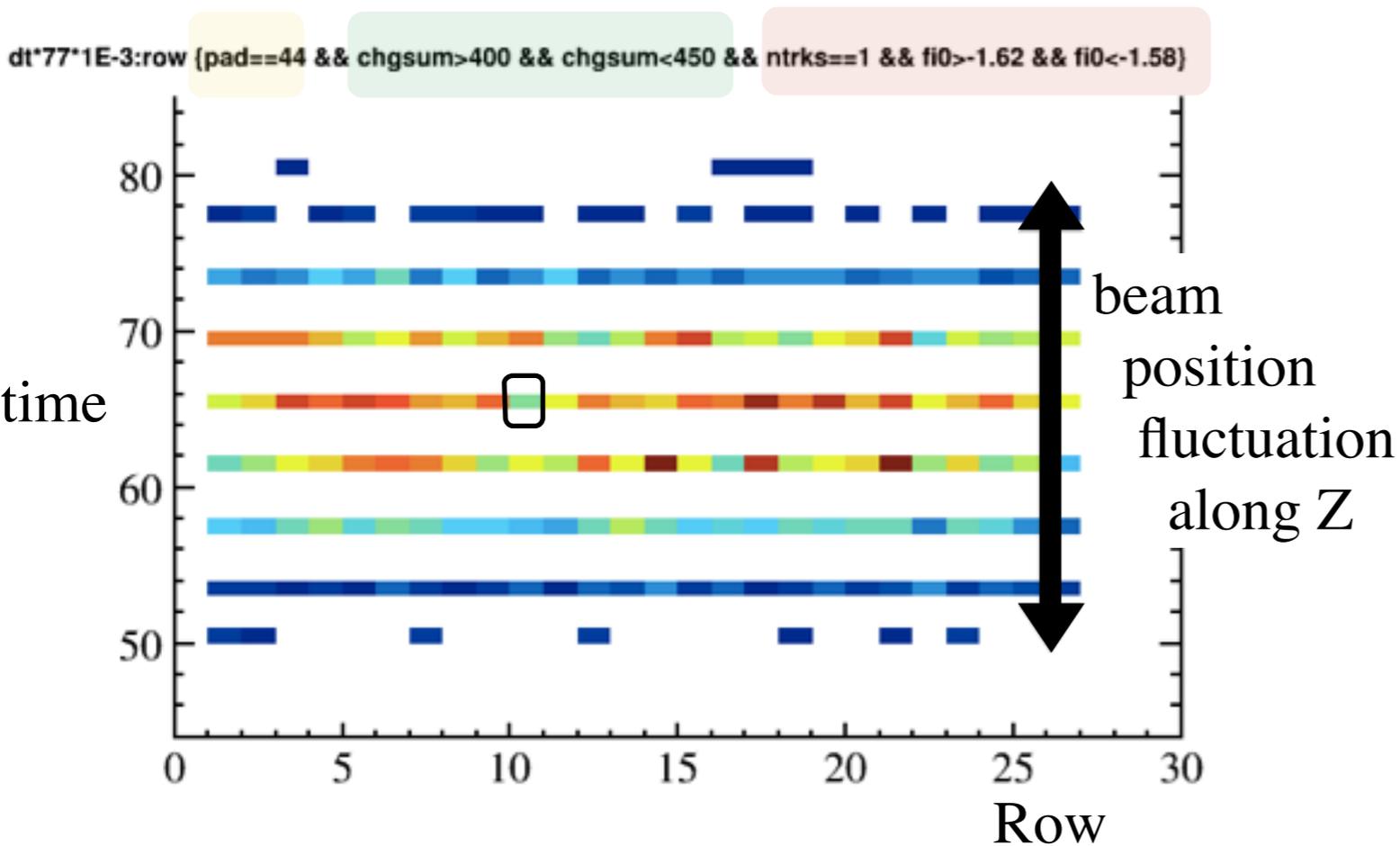
Cluster time

If every channels synchronously start sampling, pulse time should be same especially for very short drift data and pads located in same pads.



Time vs Pad 44 (of each row)
Notice: time estimator is MaxADCBin

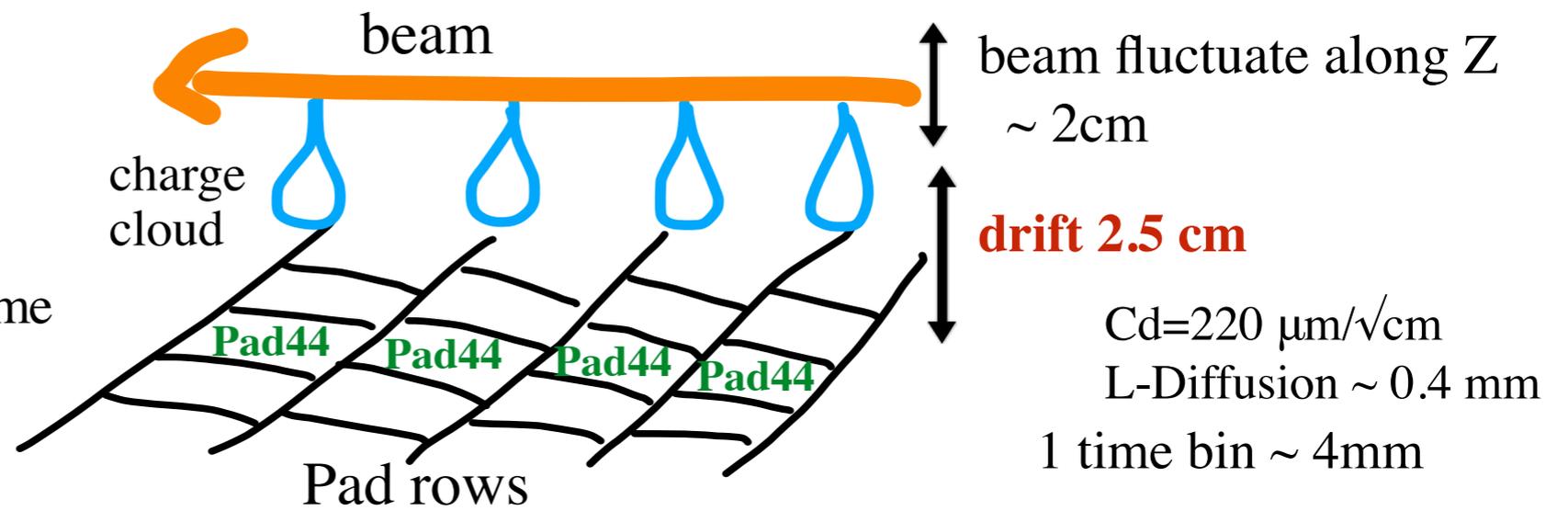
only pad 44 (same position along $r\phi$)
similar charge distributions may be similar pulse shape. track quality cuts



0

Cluster time

If every channels synchronously start sampling, pulse time should be same especially for very short drift data and pads located in same pads.

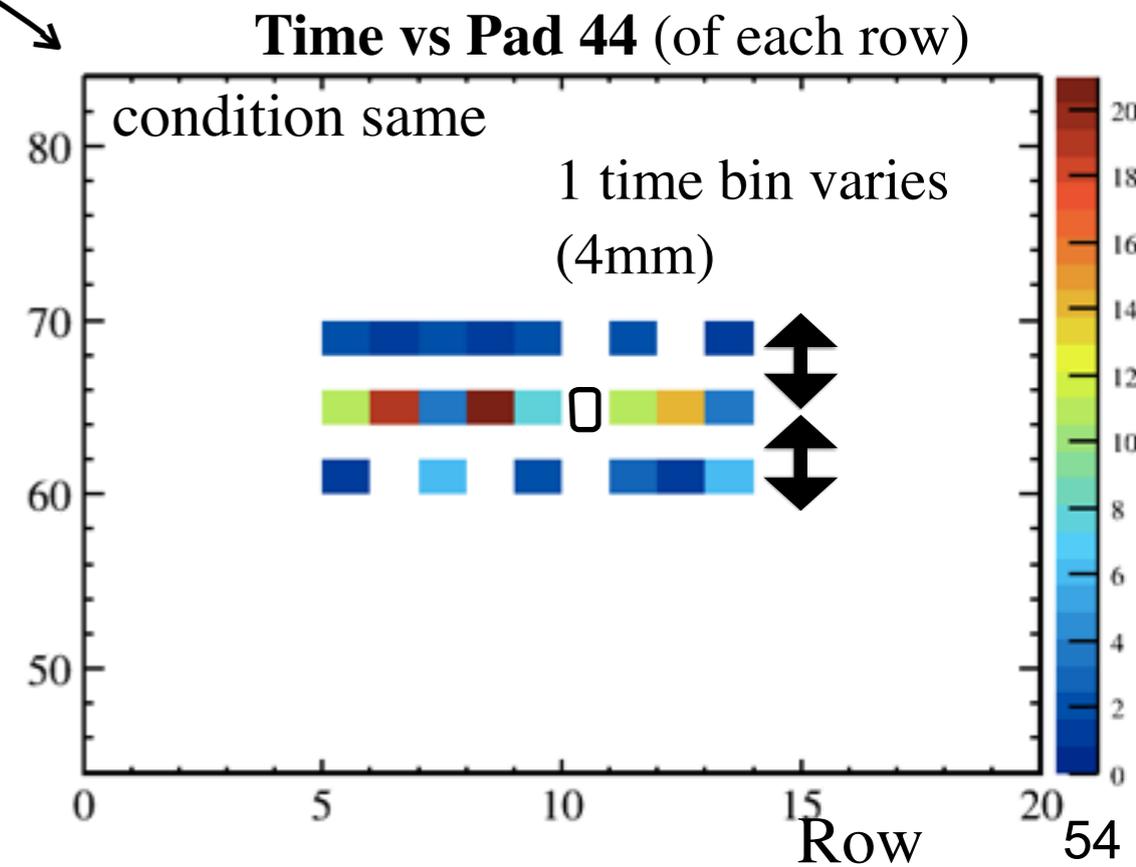
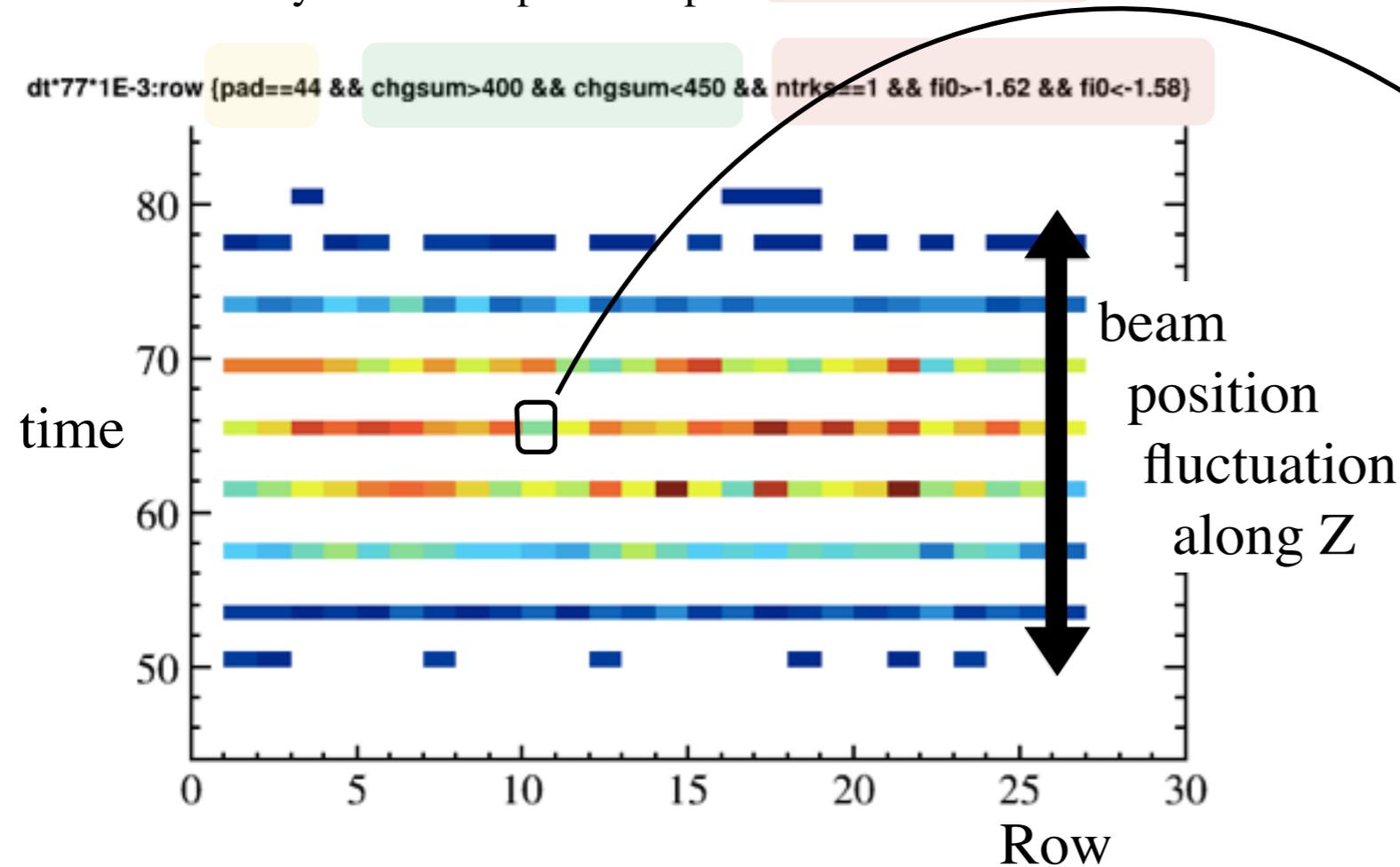


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Notice: time estimator is MaxADCBin

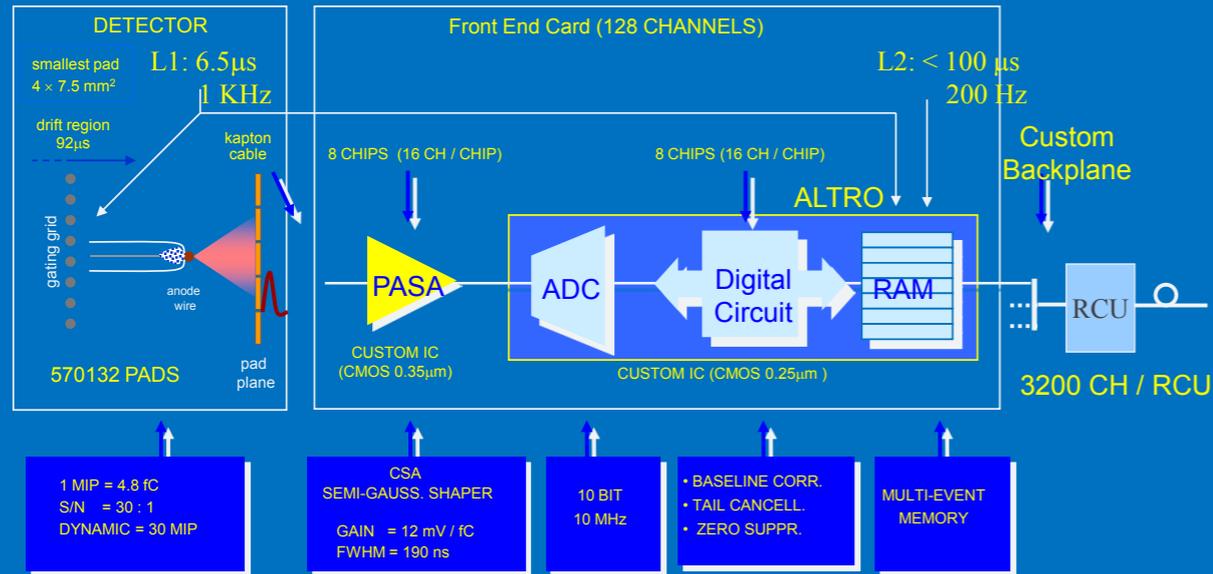
only pad 44 (same position along $r\phi$)
similar charge distributions may be similar pulse shape. track quality cuts

If Time of the pad44 in the row 10 is \square , the other rows has which time ?

If synchro. (sampling clock chan by chan) is completed, values can be seen next to \square .

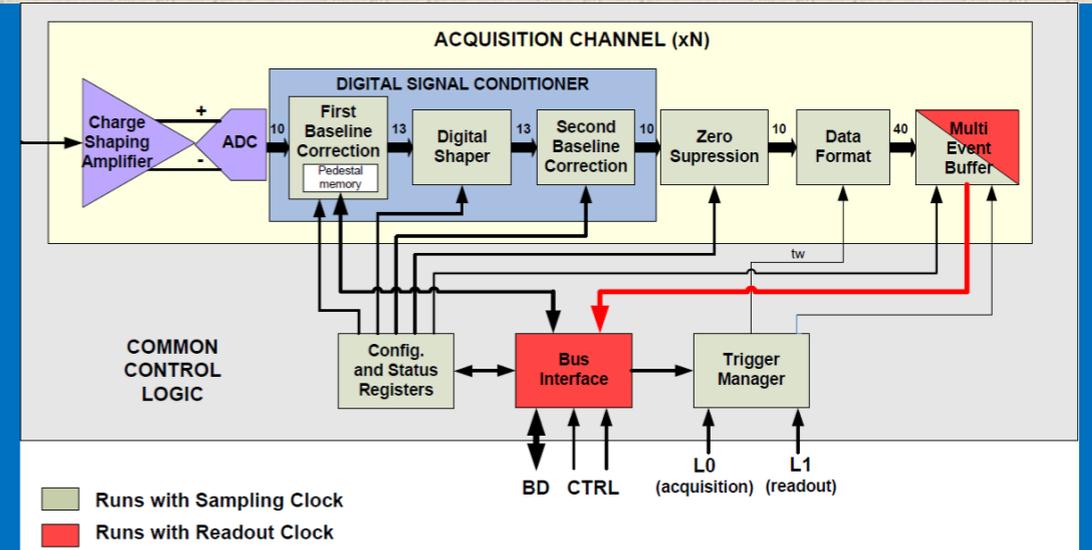


Alice TPC: ALTRO



PreAmplifier Shaping Amplifier = PASA
ALice Tpc Read Out = ALTRO
Two-chips system, 4x7.5mm pads

System architecture



Level 1: Starts the data acquisition.

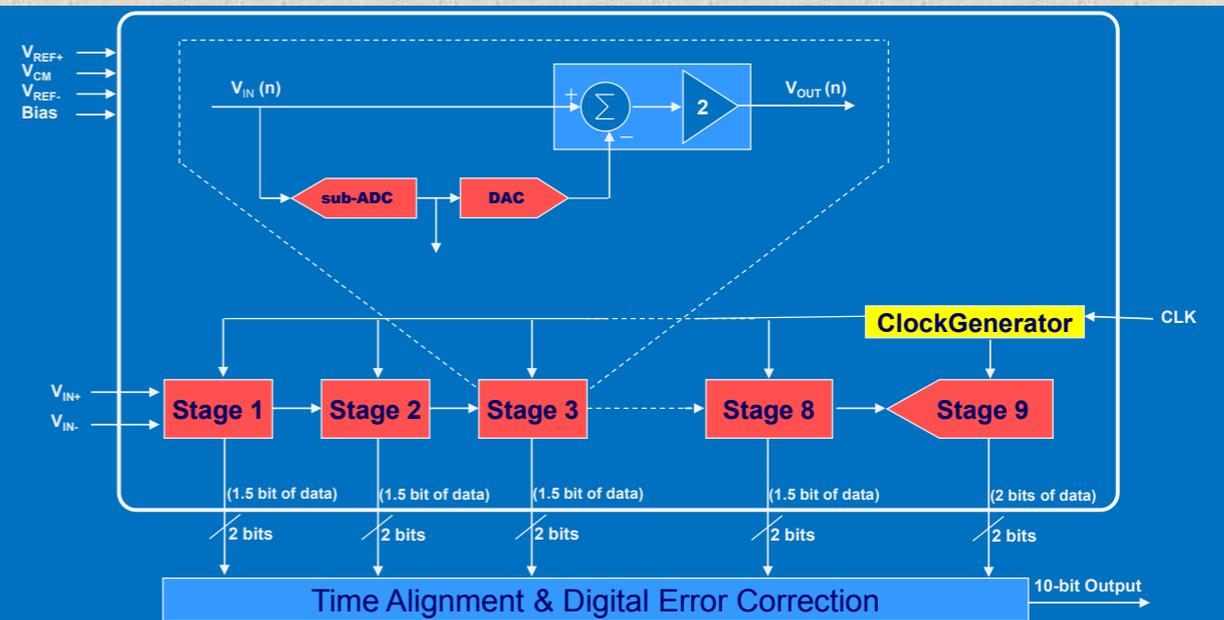
Level 2: Validates data from previous L1.

BD : 40 bit bidirectional bus; 20 bits address + 20 bit data.

CTRL : 6 bits.

Sampling clock : max 40MHz. Readout clock : max 80MHz.

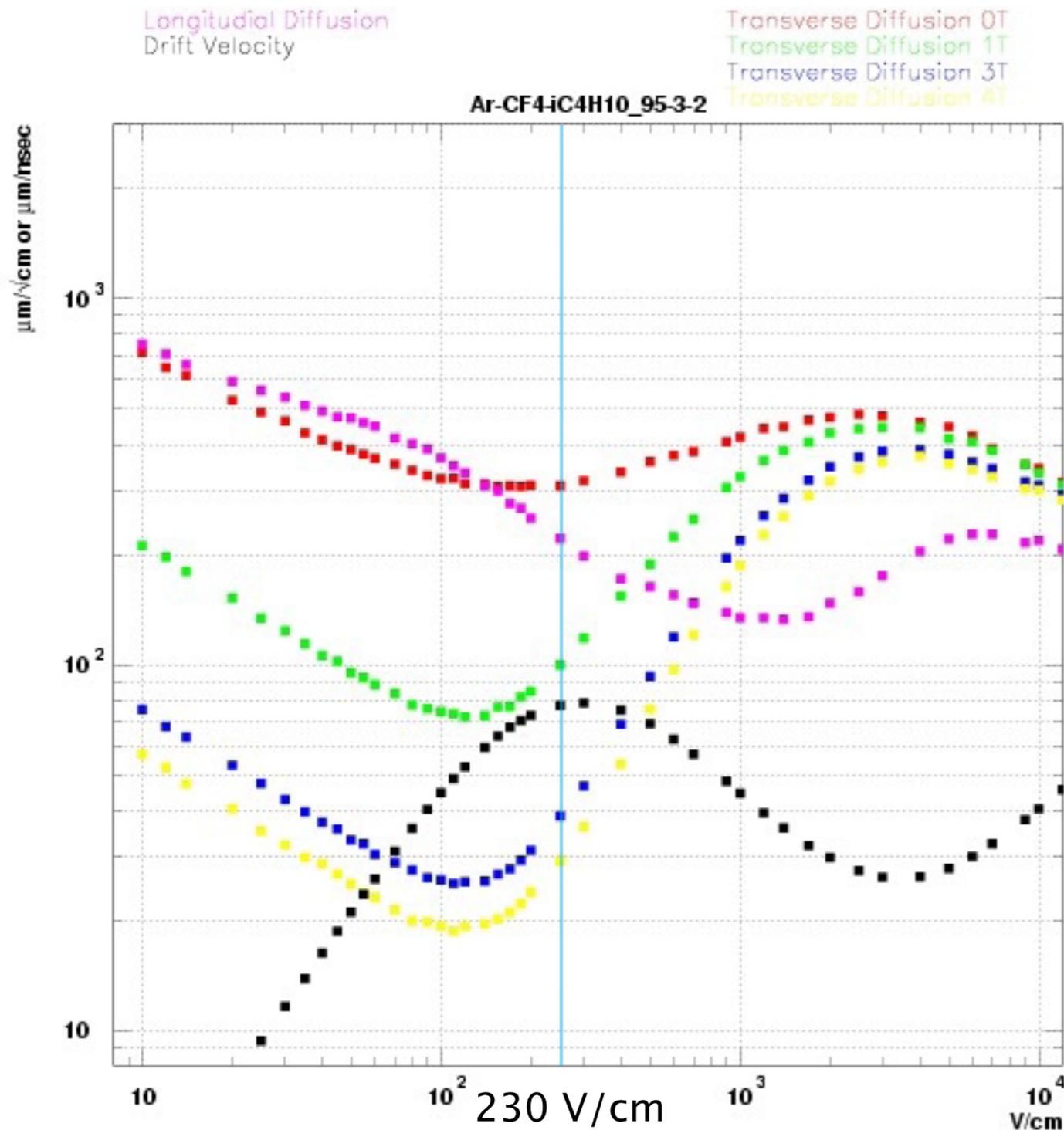
Pipeline ADC



CERN ADC prototype by Hugo França-Santos:

10bit, 40MHz, 1.5V supply, 34mW power, 0.7mm² area

Drift velocity and diffusion (T2K gas)

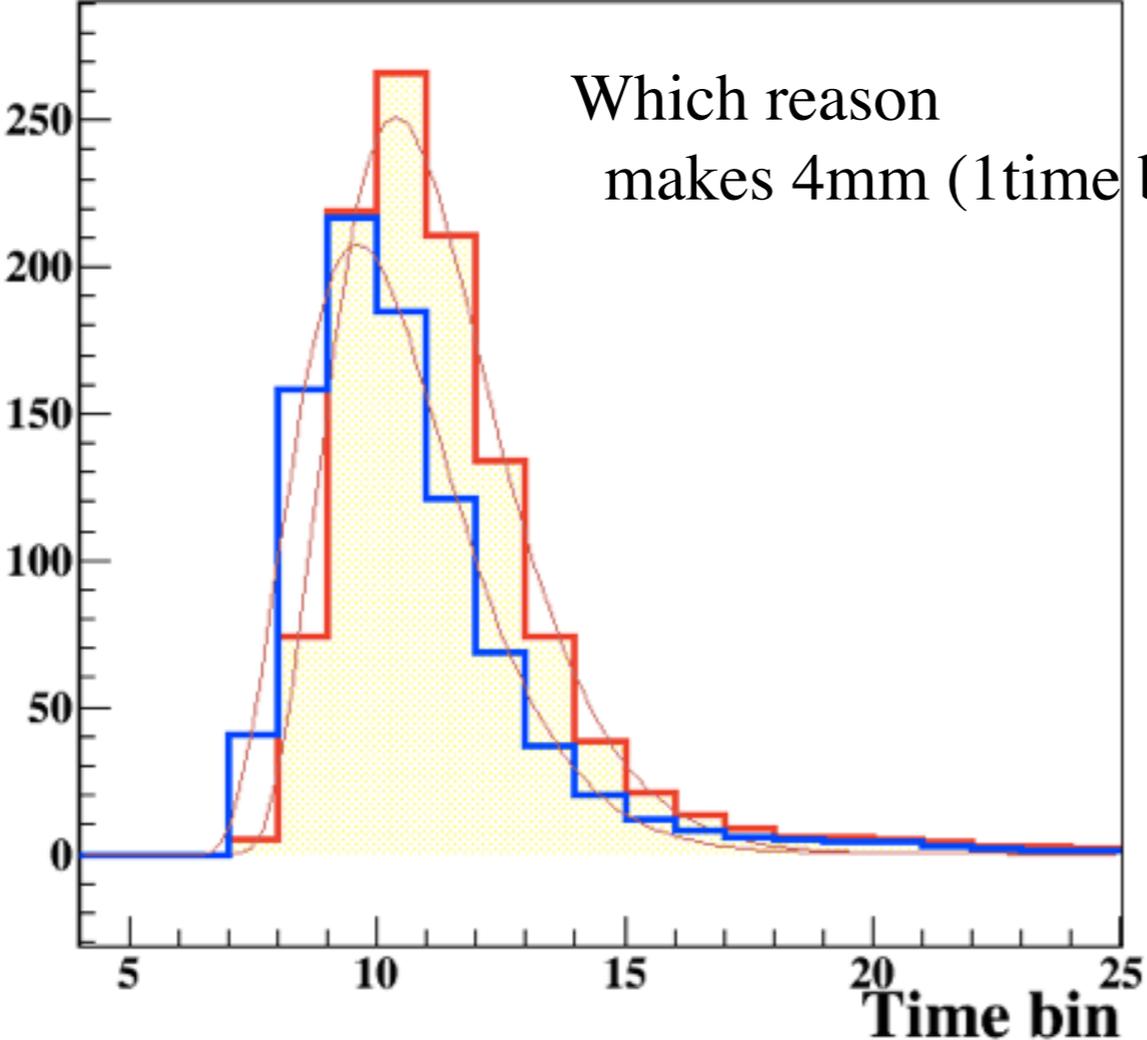


If we require the azimuthal resolution of 100 μm at $z = 200$ cm the diffusion constant (D), which is essentially the only free (controllable) parameter depending on the choice of gas mixture, needs to be smaller than $30 \mu\text{m}/\sqrt{\text{cm}}$.

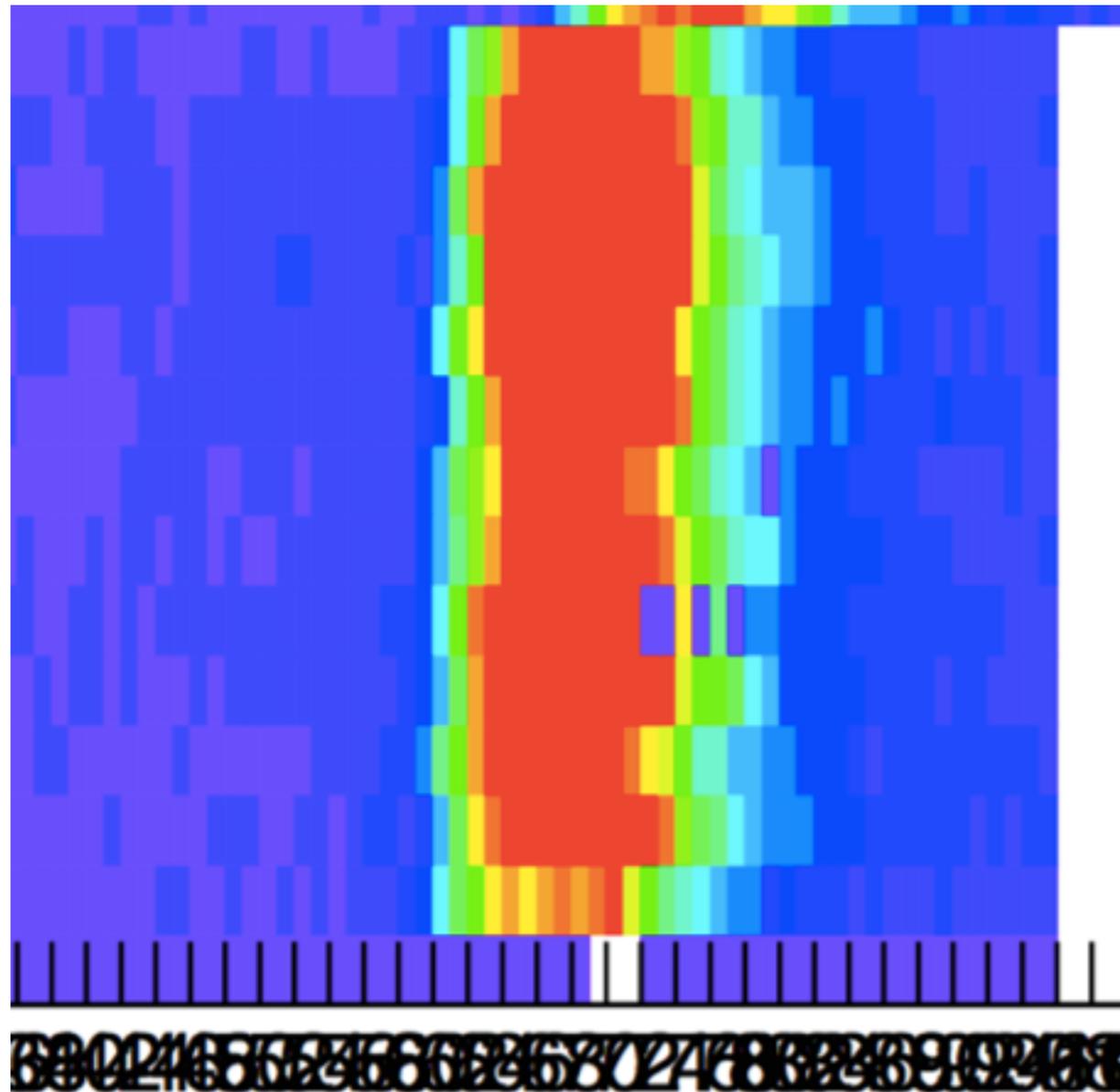
The diffusion constant of drift electrons under the influence of an axial magnetic field (B) is given by $D(B) = D(B = 0)/\sqrt{1 + (\omega\tau)^2}$, where $\omega \equiv e \cdot B/m$, the electron cyclotron frequency, and τ is the mean free time of drift electrons between collisions with gas molecules. Therefore we need a gas mixture in which $D(B = 0)$ is small (cool) and τ is fairly large (fast) under a moderate drift field (E)!

- ▶ The diffusion constant D is related to the diffusion coefficient (D^*) through $D^2 = 2D^*/W$, where W is the electron drift velocity.
- ▶ The electron drift velocity is given by $W = e \cdot E/m \cdot \tau$ with e (m) being the electron charge (mass). A large value of τ , therefore, means a fast gas.

hPulse0_row10_pad91



Which reason makes 4mm (1time bin)?



along $\phi \sim 15\text{pads} \sim *1.2\text{mm} \sim 2\text{cm}$

$r\phi$ resolution — Beam test —

- Determination of “hit position”
→ the Charge centroid method.
- Evaluated N_{eff} for the both module.
Ave. of the central 20 rows.
(C_D is measured with the same terms)
- { the gating GEM: $N_{\text{eff}} = 22.8 \pm 0.3$
- { the field shaper: $N_{\text{eff}} = 28.5 \pm 0.4$
- Ratio of the Ave. $N_{\text{eff}} \sim 80.1 \pm 1.2 \%$

Geometric mean resolution $\sigma_{r\phi} = \sqrt{\sigma_{r\phi(\text{in})}\sigma_{r\phi(\text{out})}}$

<https://agenda.linearcollider.org/event/7507/contributions/39322/>

